



## MIC3002

### FOM Management IC with Internal Calibration

#### General Description

The MIC3002 is a fiber optic module controller which enables the implementation of sophisticated, hot-pluggable fiber optic transceivers with intelligent laser control and an internally calibrated Digital Diagnostic Monitoring Interface per SFF-8472. It essentially integrates all non-datapath functions of an SFP transceiver into a tiny (4mm x 4mm) QFN package. It also works well as a microcontroller peripheral in transponders or 10Gbps transceivers.

A highly configurable automatic power control (APC) circuit controls laser bias. Bias and modulation are temperature compensated using dual DACs, an on-chip temperature sensor, and NVRAM look-up tables. A programmable internal feedback resistor provides a wide dynamic range for the APC. Controlled laser turn-on facilitates hot plugging.

An analog-to-digital converter converts the measured temperature, voltage, bias current, transmit power, and received power from analog to digital. An EEPROM provides front-end adjustment of RX power. Each parameter is compared against user-programmed warning and alarm thresholds. Analog comparators and DACs provide high-speed monitoring of received power and critical laser operating parameters. Data can be reported as either internally calibrated or externally calibrated.

An interrupt output, power-on hour meter, and data-ready bits add user friendliness beyond SFF-8472. The interrupt output and data-ready bits reduce overhead in the host system. The power-on hour meter logs operating hours using an internal real-time clock and stores the result in NVRAM.

In addition to the features listed above which are already implemented in the previous controller MIC3001, the MIC3002 features an extensive temperature range, options to mask alarms and warnings interrupt and TXFAULT, and ability to support up to four chips with the same address on the serial interface.

Communication with the MIC3002 is via an industry standard 2-wire serial interface. Nonvolatile memory is provided for serial ID, configuration, and separate OEM and user scratchpad spaces. Two-level password protection guards against data corruption.

#### Features

- Extensive temperature range
- Alarms and Warnings interrupt and TXFAULT masks
- Capability to support up to four chips on the serial interface
- LUT to compensate for chip-FOM case temperature difference
- APC or constant-current laser bias
- Turbo mode for APC loop start-up and shorter laser turn on time
- Supports multiple laser types and bias circuit topologies
- Integrated digital temperature sensor
- Temperature compensation of modulation, bias, and fault levels via NVRAM look-up tables
- NVRAM to support GBIC/SFP serial ID function
- User writable EEPROM scratchpad
- Diagnostic monitoring interface per SFF-8472
  - Monitors and reports critical parameters: temperature, bias current, TX and RX optical power, and supply voltage
  - S/W control and monitoring of TXFAULT, RXLOS, RATESELECT, and TXDISABLE
  - Internal or external calibration
  - EEPROM for adjusting RX power measurement
- Power-on hour meter
- Interrupt capability
- Extensive test and calibration features
- 2-wire SMBus-compatible serial interface
- SFP/SFP+ MSA and SFF-8472 compliant
- 3.0V to 3.6V power supply range
- 5V-tolerant I/O
- Available in (4mm x 4mm) 24-pin QFN package

#### Applications

- SFP/SFP+ optical transceivers
- SONET/SDH transceivers and transponders
- Fibre Channel transceivers
- 10Gbps transceivers
- Free space optical communications
- Proprietary optical links

## Ordering Information

Part Number	Package Type	Junction Temp. Range	Package Marking	Lead Finish
MIC3002BML	24-pin QFN	–45°C to +105°C	3002	Sn-Pb
MIC3002BMLTR <sup>(1)</sup>	24-pin QFN	–45°C to +105°C	3002	Sn-Pb
MIC3002GML	24-pin QFN	–45°C to +105°C	3002 with Pb-Free bar-line indicator	Pb-Free NiPdAu
MIC3002GMLTR <sup>(1)</sup>	24-pin QFN	–45°C to +105°C	3002 with Pb-Free bar-line indicator	Pb-Free NiPdAu

1. **Note:**

2. Tape and Reel.

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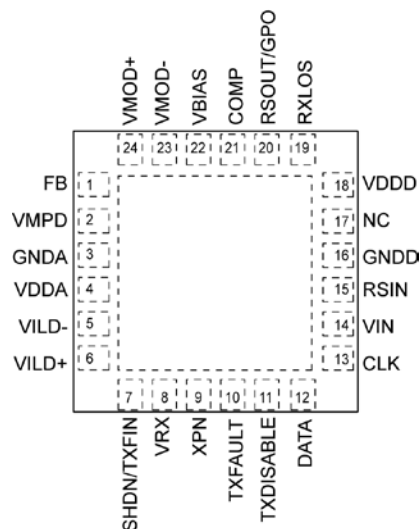
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## Pin Configuration



24-Pin QFN

## Pin Description

Pin Number	Pin Name	Pin Function
1	FB	Analog Input. Feedback voltage for the APC loop op-amp. Polarity and scale are programmable via the APC configuration bits. Connect to $V_{BIAS}$ if APC is not used.
2	VMPD	Analog Input. Multiplexed A/D converter input for monitoring transmitted optical power via a monitor photodiode. In most applications, VMPD will be connected directly to FB. The input range is $0 - V_{REF}$ or $0 - V_{REF}/4$ depending on the setting of the APC configuration bits
3	GNDA	Ground return for analog functions.
4	VDDA	Power supply input for analog functions.
5	VILD-	Analog Input. Reference terminal for the multiplexed pseudo-differential A/D converter inputs for monitoring laser bias current via a sense resistor (VILD+ is the sensing input). Tie to $V_{DD}$ or GND to reference the voltage sensed on VILD+ to $V_{DD}$ or GND, respectively. Limited common-mode voltage range, see "Applications Information" section for more details.
6	VILD+	Analog Input. Multiplexed A/D input for monitoring laser bias current via a sense resistor (signal input); accommodates inputs referenced to $V_{DD}$ or GND (see pin 5 description). Limited common-mode voltage range, see "Applications Information" section for more details.
7	SHDN/TXFIN	Digital output/Input; programmable polarity. When used as shutdown output (SHDN), OEMCFG3-2 set to 0, SHDN is asserted at the detection of a fault condition if OEMCFG4-7 is set to 0. If the latter bit is set to 1, a fault condition will not assert SHDN. When programmed as TXFIN, it is an input for external fault signals to be ORed with the internal fault sources to drive TXFAULT.
8	VRX	Analog Input. Multiplexed A/D converter input for monitoring received optical power. The input range is $0$ to $V_{REF}$ . A 5-bit programmable EEPOT on this pin provides for coarse calibration and ranging of the RX power measurement.
9	XPN	Analog Input/Output. Optional connection to an external PN junction for sensing temperature at a remote location. The Zone bit in OEMCFG1 determines whether temperature is measured using the on-chip sensor or the remote PN junction.
10	TXFAULT	Digital Output; Open-Drain, programmable polarity. If OEMCFG5-4 is set to 0, a high level indicates a hardware fault impeding transmitter operation. The state of this pin is always reflected in the TXFLT bit.

## Pin Description

Pin Number	Pin Name	Pin Function
11	TXDISABLE	Digital Input; Active High. The transmitter is disabled when this line is high or the STXDIS bit is set. The state of this input is always reflected in the TXDIS bit.
12	DATA	Digital I/O; Open-drain. Bi-directional serial data input/output.
13	CLK	Digital Input; Serial clock input.
14	VIN/INT	If bit 4 (IE) in USRCTL register is set to 0 (default), this pin is configured as analog input. If IE bit is set to 1, this pin is configured as open-drain output. Analog Input: Multiplexed A/D input for monitoring supply voltage. 0V to 5.5V input range. Open-drain output: outputs the internally generated interrupt signal /INT.
15	RSIN	Digital Input; Rate Select Input; ORed with rate select bit to determine the state of the RSOUT pin. The state of this pin is always reflected in the RSEL bit.
16	GNDD	Ground return for digital functions.
17	NC	No connection. This pin is used for test purposes and must be left unconnected.
18	VDDD	Power supply input for digital functions.
19	RXLOS	Digital Output; programmable polarity Open-Drain. Indicates the loss of the received signal as indicated by a level of received optical power below the programmed RXLOS comparator threshold; may be wire-ORed with external signals. Normal operation is indicated by a Low level when OEMCFG6-3 is set to 0 and a high level when OEMCFG6-3 is set to 1. RXLOS is de-asserted when $VRX > LOSFLN$ . The LOS bit reflects the state of RXLOS whether driven by the MIC3002 or an external circuit.
20	RS0/GPO	Digital Output. Open-Drain or push-pull. When used as rate select output, it represents the receiver rate select as per SFF. This output is controlled by the SRSEL bit ORed with RSIN input and is open drain only. When used as a general-purpose, non-volatile output, it is controlled by the GPO configuration bits in OEMCFG3.
21	COMP	Analog Output, compensation terminal. Connect a capacitor between this pin and GNDA or VDDA with appropriate value to tune the APC loop time constant to a desirable value.
22	VBIAS	Analog Output. Buffered DAC output capable of sourcing or sinking up to 10mA under control of the APC function to drive an external transistor for laser diode D.C. bias. The output and feedback polarity are programmable to accommodate either a NPN or a PNP transistor to drive a common-anode or common-cathode laser diode.
23	VMOD-	Analog Input. Inverting terminal of VMOD buffer op-amp. Connect to $V_{MOD+}$ (gain = 1) or feedback resistors network to set a different gain
24	VMOD+	Analog Output. Buffered DAC output to set the modulation current on the laser driver IC. Operates with either a $0 - V_{REF}$ or a $(V_{DD} - V_{REF}) - V_{DD}$ output swing so as to generate either a ground-referenced or a $V_{DD}$ referenced programmed voltage. A simple external circuit can be used to generate a programmable current for those drivers that require a current rather than a voltage input. See "Applications Information" section for more details.



**Absolute Maximum Ratings<sup>(1)</sup>**

Power Supply Voltage,  $V_{DD}$  ..... +3.8V  
 Voltage on CLK, DATA, TXFAULT, VIN, RXLOS,  
 DISABLE, RSIN ..... -0.3V to +6.0V  
 Voltage On Any Other Pin ..... -0.3V to  $V_{DD}+0.3V$   
 Power Dissipation,  $T_A = 85^\circ\text{C}$  ..... 1.5W  
 Junction Temperature ( $T_J$ ) ..... 150°C  
 Storage Temperature ( $T_S$ ) ..... -65°C to +150°C  
 ESD Ratings<sup>(3)</sup>  
   Human Body Model ..... 2kV  
   Machine Model ..... 300V  
 Soldering (20sec) ..... 260°C

**Operating Ratings<sup>(2)</sup>**

Power Supply Voltage,  $V_{DDA}/V_{DDD}$  ..... +3.0V to +3.6V  
 Ambient Temperature Range ( $T_A$ ) ... -40°C to +105°C  
 Package Thermal Resistance  
   QFN ( $\theta_{JA}$ ) ..... 43°C/W

**Electrical Characteristics**

For typical values,  $T_A = 25^\circ\text{C}$ ,  $V_{DDA} = V_{DDD} = +3.3V$ , unless otherwise noted. **Bold** values are guaranteed for  $+3.0V \leq (V_{DDA} = V_{DDD}) \leq 3.6V$ ,  $T_{(min)} \leq T_A \leq T_{(max)}$ <sup>(8)</sup>

Symbol	Parameter	Condition	Min	Typ	Max	Units
<b>Power Supply</b>						
$I_{DD}$	Supply Current	CLK = DATA = $V_{DDD} = V_{DDA}$ ; TXDISABLE low; all DACs at full- scale; all A/D inputs at full-scale; all other pins open.		2.3	3.5	mA
		CLK = DATA = $V_{DDD} = V_{DDA}$ ; TXDISABLE high; FLTDAC at full- scale; all A/D inputs at full-scale; all other pins open.		2.3	3.5	mA
$V_{POR}$	Power-on Reset Voltage	All registers reset to default values; A/D conversions initiated.		2.9	2.98	V
$V_{UVLO}$	Under-Voltage Lockout Threshold	Note 5	2.5	2.73		V
$V_{HYST}$	Power-on Reset Hysteresis Voltage			170		mV
$t_{POR}$	Power-on Reset Time	$V_{DD} > V_{POR}$ <sup>(4)</sup>		50		$\mu\text{s}$
$V_{REF}$	Reference Voltage		1.210	1.225	1.240	V
$\Delta V_{REF}/\Delta V_{DDA}$	Voltage Reference Line Regulation			1.7		mV/V

**Temperature-to-Digital Converter Characteristics**

	Local Temperature Measurement Error	$-40^\circ\text{C} \leq T_A \leq +105^\circ\text{C}$ <sup>(6)</sup>		$\pm 1$	$\pm 3$	$^\circ\text{C}$
	Remote Temperature Measurement Error	$-40^\circ\text{C} \leq T_A \leq +105^\circ\text{C}$ <sup>(6)</sup>		$\pm 1$	$\pm 3$	$^\circ\text{C}$
$t_{CONV}$	Conversion Time	Note 4			60	ms
$t_{SAMPLE}$	Sample Period				100	ms

**Remote Temperature Input, XPN**

$I_F$	Current to External Diode <sup>(4)</sup>	XPN at high level, clamped to 0.6V.		192	400	$\mu\text{A}$
		XPN at low level, clamped to 0.6V.	7	12		$\mu\text{A}$

**Voltage-to-Digital Converter Characteristics ( $V_{RX}$ ,  $V_{AUX}$ ,  $V_{BIAS}$ ,  $V_{MPD}$ ,  $V_{ILD\pm}$ )**

Symbol	Parameter	Condition	Min	Typ	Max	Units
	Voltage Measurement Error	$-40^{\circ}\text{C} \leq T_A \leq +105^{\circ}\text{C}^{(6)}$		$\pm 1$	$\pm 2.0$	%fs
$t_{\text{CONV}}$	Conversion Time	Note 4			10	ms
$t_{\text{SAMPLE}}$	Sample Period	Note 4			100	ms

**Voltage Input,  $V_{IN}$  (Pin 14 used as an ADC Input)**

$V_{IN}$	Input Voltage Range	$-0.3 \leq V_{DD} \leq 3.6\text{V}$	GNDA		5.5	V
$I_{\text{LEAK}}$	Input Current	$V_{IN} = V_{DD}$ or GND; $V_{AUX} = V_{IN}$		55		$\mu\text{A}$
$C_{IN}$	Input Capacitance			10		pF

**Digital-to-Voltage Converter Characteristics ( $V_{MOD}$ ,  $V_{BIAS}$ )**

	Accuracy	$-40^{\circ}\text{C} \leq T_A \leq +105^{\circ}\text{C}^{(6)}$		$\pm 1$	2.0	%fs
$t_{\text{CONV}}$	Conversion Time	Note 4			20	ms
DNL	Differential Non-linearity Error	Note 4		$\pm 0.5$	$\pm 1$	LSB

**Bias Current Sense Inputs,  $V_{ILD+}$ ,  $V_{ILD-}$** 

$V_{ILD}$	Differential Input Signal Range, $ V_{ILD+} - V_{ILD-} $		0		$V_{\text{REF}}/4$	mV
$I_{\text{IN}+}$	$V_{ILD+}$ input current				$\pm 1$	$\mu\text{A}$
$I_{\text{IN}-}$	$V_{ILD-}$ input current $ V_{ILD+} - V_{ILD-}  = 0.3\text{V}$	$V_{ILD-}$ referred to $V_{\text{DDA}}$		+150		$\mu\text{A}$
		$V_{ILD-}$ referred to GND		-150		$\mu\text{A}$
$C_{IN}$	Input Capacitance			10		pF

**APC Op Amp, FB,  $V_{BIAS}$ , COMP**

GBW	Gain Bandwidth Product	$C_{\text{COMP}} = 20\text{pF}$ ; Gain = 1		1		MHz
$\text{TC}_{\text{VOS}}$	Input Offset Voltage Temperature Coefficient <sup>(4)</sup>			1		$\mu\text{V}/^{\circ}\text{C}$
$V_{\text{OUT}}$	Output Voltage Swing	$I_{\text{OUT}} = 10\text{mA}$ , SRCE bit = 1	GNDA		1.25	V
		$I_{\text{OUT}} = -10\text{mA}$ , SRCE bit = 0	$V_{\text{DDA}} - 1.25$		$V_{\text{DDA}}$	V
$I_{\text{SC}}$	Output Short-Circuit Current			55		mA
$t_{\text{SC}}$	Short Circuit Withstand Time	$T_J \leq 150^{\circ}\text{C}^{(4)}$				sec
PSRR	Power Supply Rejection Ratio	$C_{\text{COMP}} = 20\text{pF}$ ; Gain = 1, to GND		55		dB
		$C_{\text{COMP}} = 20\text{pF}$ ; Gain = 1, to $V_{\text{DD}}$		40		
$A_{\text{MIN}}$	Minimum Stable Gain	$C_{\text{COMP}} = 20\text{pF}$ , Note 4			1	V/V
$\Delta V/\Delta t$	Slew Rate	$C_{\text{COMP}} = 20\text{pF}$ ; Gain = 1		3		V/ $\mu\text{s}$
$\Delta\text{RFB}$	Internal Feedback Resistor Tolerance			$\pm 20$		%
$\Delta\text{RFB}/\Delta t$	Internal Feedback Resistor Temperature Coefficient			25		ppm/C
$I_{\text{START}}$	Laser Start-up Current Magnitude	START = 01 <sub>h</sub>		0.375		mA
		START = 02 <sub>h</sub>		0.750		mA
		START = 04 <sub>h</sub>		1.500		mA
		START = 08 <sub>h</sub>		3.000		mA
$C_{IN}$	Pin Capacitance			10		pF

## Electrical Characteristics

Symbol	Parameter	Condition	Min	Typ	Max	Units
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### V<sub>MOD</sub> Buffer Op-Amp, V<sub>MOD+</sub>, V<sub>MOD-</sub>

GBW	Gain Bandwidth	C <sub>COMP</sub> = 20pF; Gain = 1		1		MHz
TC <sub>VOS</sub>	Input Offset Voltage Temperature Coefficient			1		μV/°C
I <sub>BIAS</sub>	V <sub>MOD-</sub> Input Current			±0.1	±1	μA
V <sub>OUT</sub>	Output Voltage Swing	I <sub>OUT</sub> = ±1mA	GND+75		V <sub>DDA</sub> -75	mV
I <sub>SC</sub>	Output Short-Circuit Current			35		mA
t <sub>SC</sub>	Short Circuit Withstand Time	T <sub>J</sub> ≤ 150°C <sup>(4)</sup>				sec
PSRR	Power Supply Rejection Ratio	C <sub>COMP</sub> = 20pF; Gain = 1, to GND		65		dB
		C <sub>COMP</sub> = 20pF; Gain = 1, to V <sub>DD</sub>		44		dB
A <sub>MIN</sub>	Minimum Stable Gain	C <sub>COMP</sub> = 20pF			1	V/V
ΔV/ΔT	Slew Rate	C <sub>COMP</sub> = 20pF; Gain = 1		1		V/μs
C <sub>IN</sub>	Pin Capacitance			10		pF

### Control and Status I/O, TXDISABLE, TXFAULT, RSIN, RSOUT(GPO), SHDN(TXFIN), RXLOS, /INT

V <sub>IL</sub>	Low Input Voltage				0.8	V
V <sub>IH</sub>	High Input Voltage		2.0			V
V <sub>OL</sub>	Low Output Voltage	I <sub>OL</sub> ≤ 3mA			0.3	V
V <sub>OH</sub>	High Output Voltage (applies to SHDN only)	I <sub>OH</sub> ≤ 3mA			V <sub>DD</sub> -0.3	V
I <sub>LEAK</sub>	Input Current				±1	μA
C <sub>IN</sub>	Input Capacitance			10		pF

### Transmit Optical Power Input, V<sub>MPD</sub>

V <sub>IN</sub>	Input Voltage Range	Note 4	GND+75		V <sub>DDA</sub>	V
V <sub>RX</sub>	Input Signal Range	BIASREF=0			V <sub>REF</sub>	V
		BIASREF=1	V <sub>DDA</sub> -V <sub>REF</sub>		V <sub>DDA</sub>	V
C <sub>IN</sub>	Input Capacitance	Note 4		10		pF
I <sub>LEAK</sub>	Input Current				±1	μA

### Received Optical Power Input, VRX, RXPOT

	Input Voltage Range	Note 4	GND+75		V <sub>DDA</sub>	V
V <sub>RX</sub>	Valid Input Signal Range (ADC Input Range)		0		V <sub>REF</sub>	V
R <sub>RXPOT(32)</sub>	End-to-End Resistance	RXPOT = 1F <sub>h</sub>		32		KΩ
ΔRXPOT	Resistor Tolerance			±20		%
ΔRXPOT/ΔT	Resistor Temperature Coefficient			25		ppm/C
ΔV <sub>RX</sub> /V <sub>RXPOT</sub>	Divider Ratio Accuracy	00 ≤ RXPOT ≤ 1F <sub>h</sub>	-5		+5	%
I <sub>LEAK</sub>	Input Current	RXPOT = 0 (disconnected)			±1	μA
C <sub>IN</sub>	Input Capacitance	Note 4		10		pF
I <sub>LEAK</sub>	Input Current				±1	μA

## Electrical Characteristics

Symbol	Parameter	Condition	Min	Typ	Max	Units
<b>Control and Status I/O Timing, TXFAULT, TXDISABLE, RSIN, RSOUT, and RXLOS</b>						
$t_{OFF}$	TXDISABLE Assert Time	From input asserted to optical output at 10% of nominal, $C_{COMP} = 10nF$ .			<b>10</b>	$\mu s$
$t_{ON}$	TXDISABLE De-assert Time	From input de-asserted to optical output at 90% of nominal, $C_{COMP} = 10nF$ .			<b>1</b>	ms
$t_{INIT}$	Initialization Time	From power on or transmitter enabled to optical output at 90% of nominal and TX_FAULT de-asserted. <sup>(4)</sup>			<b>300</b>	ms
$t_{INIT2}$	Power-on Initialization Time	From power on to APC loop-enabled.			<b>200</b>	ms
$t_{FAULT}$	TXFAULT Assert Time	From fault condition to TXFAULT assertion. <sup>(4)</sup>			95	$\mu s$
$t_{RESET}$	Fault Reset Time	Length of time TXDISABLE must be asserted to reset fault condition.	<b>10</b>			$\mu s$
$t_{LOSS\_ON}$	RXLOS Assert Time	From loss of signal to RXLOS asserted.			95	$\mu s$
$t_{LOSS\_OFF}$	RXLOS De-assert Time	From signal acquisition to LOS de-asserted.			<b>100</b>	$\mu s$
$t_{DATA}$	Analog Parameter Data Ready	From power on to valid analog parameter data available. <sup>(4)</sup>			<b>400</b>	ms
$t_{PROP\_IN}$	TXFAULT, TXDISABLE, RXLOS, RSIN Input Propagation Time	Time from input change to corresponding internal register bit set or cleared. <sup>(4)</sup>			<b>1</b>	$\mu s$
$t_{PROP\_OUT}$	TXFAULT, RSOUT, /INT Output Propagation Time	From an internal register bit set or cleared to corresponding output change. <sup>(4)</sup>			<b>1</b>	$\mu s$

### Fault Comparators

$\phi_{FLTMR}$	Fault Suppression Timer Clock Period	Note 4	<b>0.475</b>	0.5	<b>0.525</b>	ms
	Accuracy		-3		+3	%/F.S.
$t_{REJECT}$	Glitch Rejection	Maximum length pulse that will not cause output to change state. <sup>(4)</sup>	4.5			$\mu s$
$V_{SAT}$	Saturation Detection Threshold	High level		95		%VDDA
		Low level		5		%VDDA

### Power-On Hour Meter

	Timebase Accuracy	$0^{\circ}C \leq T_A \leq +70^{\circ}C^{(4)}$	<b>+5</b>		<b>-5</b>	%
		$-40^{\circ}C \leq T_A \leq +105^{\circ}C$	<b>+10</b>		<b>-10</b>	%
	Resolution	Note 4		10		hours

### Non-Volatile (FLASH) Memory

$t_{WR}$	Write Cycle Time(7)	From STOP of a one to four-byte write transaction. <sup>(4)</sup>			<b>13</b>	ms
	Data Retention		<b>100</b>			years
Endurance	Minimum Permitted Number Write Cycles		<b>10,000</b>			cycles

**Serial Data I/O Pin, Data**

Symbol	Parameter	Condition	Min	Typ	Max	Units
V <sub>OL</sub>	Low Output Voltage	I <sub>OL</sub> = 3mA			<b>0.4</b>	V
		I <sub>OL</sub> = 6mA			<b>0.6</b>	V
V <sub>IL</sub>	Low Input Voltage				<b>0.8</b>	V
V <sub>IH</sub>	High Input Voltage		<b>2.1</b>			V
I <sub>LEAK</sub>	Input Current				<b>±1</b>	μA
C <sub>IN</sub>	Input Capacitance	Note 4		10		pF

**Serial Clock Input, CLK**

V <sub>IL</sub>	Low Input Voltage	2.7V ≤ V <sub>DD</sub> ≤ 3.6V			<b>0.8</b>	V
V <sub>IH</sub>	High Input Voltage	2.7V ≤ V <sub>DD</sub> ≤ 3.6V	<b>2.1</b>			V
I <sub>LEAK</sub>	Input Current				<b>±1</b>	μA
C <sub>IN</sub>	Input Capacitance	Note 4		10		pF

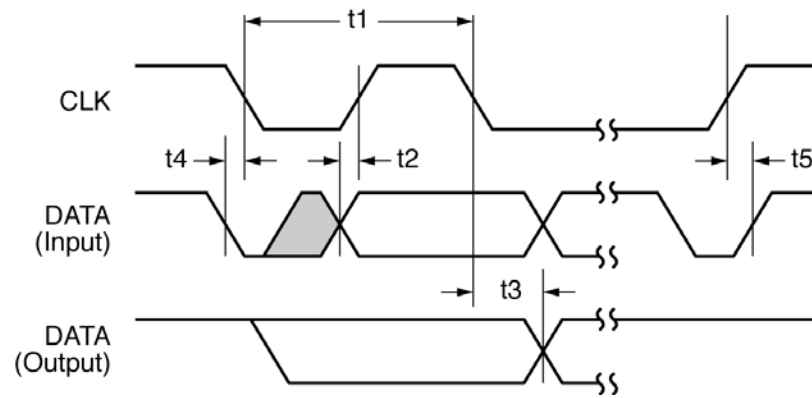
**Serial Interface Timing<sup>(4)</sup>**

t <sub>1</sub>	CLK (clock) Period		<b>2.5</b>			μs
t <sub>2</sub>	Data In Setup Time to CLK High		<b>100</b>			ns
t <sub>3</sub>	Data Out Stable After CLK Low		<b>300</b>			ns
t <sub>4</sub>	Data Low Setup Time to CLK Low	Start Condition	<b>100</b>			ns
t <sub>5</sub>	Data High Hold Time After CLK High	Stop Condition	<b>100</b>			ns
t <sub>DATA</sub>	Data Ready Time	From power on to completion of one set of ADC conversions; analog data available via serial interface.			<b>400</b>	ms

**Notes:**

1. Exceeding the absolute maximum rating may damage the device.
2. The device is not guaranteed to function outside its operating rating.
3. Devices are ESD sensitive. Handling precautions recommended.
4. Guaranteed by designing and/or testing of related parameters. Not 100% tested in production.
5. The MIC3000 will attempt to enter its shutdown state when V<sub>DD</sub> falls below V<sub>UVLO</sub>. This operation requires time to complete. If the supply voltage falls too rapidly, the operation may not be completed.
6. Does not include quantization error.
7. The MIC3002 will not respond to serial bus transactions during an EEPROM write-cycle. The host will receive a NACK during t<sub>WR</sub>.
8. Final test on outgoing product is performed at T<sub>A</sub> = +25°C.

## Timing Diagram



Serial Interface Timing

## Address Map

Address(s)	Field Size (Bytes)	Name	Description
0 – 95	96	Serial ID defined by SEP MSA	G-P NVRAM; R/W under valid OEM password.
96 – 127	32	Vendor Specific	Vendor specific EEPROM
128 – 255	128	Reserved	Reserved for future use. G-P NVRAM; R/W under valid OEM password.

**Table 1. MIC3002 Address Map, Serial Address = A0<sub>h</sub>**

Address(s)		Field Size (Bytes)	Name	Description
HEX	DEC			
00-27	0-39	40	Alarm and Warning Threshold	High/low limits for warning and alarms; writeable using OEM p/w; read-only otherwise.
28-37	40-55	16	Reserved	Reserved – do not write; reads undefined.
38-5B	56-91	36	Calibration Constants	Numerical constants for external calibration; writeable using OEM p/w; read-only otherwise.
5C-5E	92-94	3	Reserved	Reserved – do not write; reads undefined.
5F	95	1	Checksum	G-P NVRAM; writeable using OEM p/w; ready only otherwise.
60-69	96-105	10	Analog Data	Real time analog parameter data.
6A-6D	106-109	4	Reserved	Reserved – do not write; reads undefined.
6E	110	1	Control/Status Bits	Control and status bits.
6F	111	1	Reserved	Reserved – do not write; reads undefined.
70-71	112-113	2	Alarm Flags	Alarm status bits; read only.
72-73	114-115	2	Reserved	Reserved – do not write; reads undefined.
74-75	116-117	2	Warning Flags	Warning status bits; read only.
76-77	118-119	2	Reserved	Reserved – do not write; reads undefined.
78-7E	120-126	7	OEMPW	OEM password entry field. The OEM password location can be selected to be 78-7B (120-123) or 7B-7E (123-126) by setting the bit OEMCFG5 bit 2 to 0 (default) or 1.
7F	127	1	Vendor Specific	Vendor specific. Reserved – do not write; reads undefined.
80-DD	128-221	94	User Scratchpad	User writeable EEPROM. G-P NVRAM; R/W using any valid password.
DE	222	1	ALT_USRCTL	Alternate location for USRCTL register. Set bit OEMCFG6-2 to 1 to select this location. Can be used as a scratch pad if not selected.
DF-F5	223-245	23	User Scratchpad	User writeable EEPROM. G-P NVRAM; R/W using any valid password.
F6	246	1	USRPWSET	User password setting; read/write using any p/w; returns zero otherwise.
F7	247	1	USRPW	User password register
F8-F9	248-249	2	Alarms Masks	Bit =1: corresponding alarm not masked Bit = 0: corresponding alarm masked
FA-FB	250-251	2	Warnings Masks	Bit =1: corresponding warning not masked Bit = 0: corresponding warning masked
FC-FE	252-254	3	Reserved	Reserved – do not write; reads undefined.
FF	255	1	USRCTL	End-user control and status bits If ALT-USRCTL is not selected. Can be used as a scratch pad if not selected.

**Table 2. MIC3002 Address Map, Serial Address = A2<sub>h</sub>**

Address(s)		Field Size (Bytes)	Name	Description
HEX	DEC			
00-3F	0-63	64	BIASLUT1	Bias temperature compensation L.U.T. first 64 entries. Additional 12 entries are located in A6: 90-9B.
40-7F	64-127	64	MODLUT1	Modulation temperature compensation L.U.T. first 64 entries. Additional 12 entries are located in A6: A0-AB.
80-BF	128-191	64	IFTLUT1	Bias current fault threshold temperature compensation L.U.T. first 64 entries. Additional 12 entries are located in A6: B0-BB.
C0-FF	192-255	64	HATLUT1	Bias current high alarm threshold temperature compensation L.U.T. first 64 entries. Additional 12 entries are located in A6: C0-CB.

Table 3. Temperature Compensation Tables, Serial Address = A4<sub>n</sub>

Address(s)		Field Size (Bytes)	Name	Description
HEX	DEC			
00	0	1	OEMCFG0	OEM configuration register 0
01	1	1	OEMCFG1	OEM configuration register 1
02	2	1	OEMCFG2	OEM configuration register 2
03	3	1	APCSET0	APC setpoint register 0
04	4	1	APCSET1	APC setpoint register 1
05	5	1	APCSET2	APC setpoint register 2
06	6	1	MODSET0	Modulation setpoint register 0
07	7	1	IBFLT	Bias current fault-comparator threshold. This register is temperature compensated
08	8	1	TXPFLT	TX power fault threshold
09	9	1	LOSFLT	RX LOS fault-comparator threshold
0A	10	1	FLTMMR	Fault comparator timer setting
0B	11	1	FLTMASK	Fault source mask bits
0C-0F	12-15	4	OEMPWSET	Password for access to OEM areas
10	16	1	OEMCAL0	OEM calibration register 0
11	17	1	OEMCAL1	OEM calibration register 1
12	18	1	LUTINDX	Look-up table index read-back
13	19	1	OEMCFG3	OEM configuration register 3
14	20	1	APCDAC	Reads back current APC DAC value (setpoint+offset)
15	21	1	MODDAC	Reads back current modulation DAC value (setpoint+offset)
16	22	1	OEMREAD	Reads back OEM calibration data
17	23	1	LOSFLTn	LOS De-assert threshold
18	24	1	RXPOT	RXPOT tap selection
19	25	1	OEMCFG4	OEM configuration register 4
1A	26	1	OEMCFG5	OEM configuration register 5
1B	27	1	OEMCFG6	OEM configuration register 6
1C-1D	28-29	2	SCRATCH	Reserved – do not write; reads undefined.
1E	30	1	MODSET 1	Modulation setpoint register 1
1F	31	1	MODSET 2	Modulation setpoint register 2



20-27	32-39	8	POHDATA	Power-on hour meter scratchpad
28-47	40-71	32	RXLUT	RX power calibration look-up table. Eight sets of slope and offset
48-57	72-87	16	CALCOEF	Slope and offset coefficients used for Temperature, Voltage, Bias, and TXPOWER internal calibration
58-5F	88-95	8	SCRATCH	OEM scratchpad area
60-86	96-134	39	TCTRLUT	LUT to temperature-compensate temperature results and/or temperature to be used by parameters compensation LUT.
87-8F	135-143	9	SCRATCH	OEM scratchpad area.
90-9B	144-155	12	BIASLUT2	Bias temperature compensation L.U.T. additional 12 entries.
9C-9F	156-159	4	SCRATCH	OEM scratchpad area
A0-AB	160-171	12	MODLUT2	Modulation temperature compensation L.U.T. additional 12 entries.
AC-AF	172-175	14	SCRATCH	OEM scratchpad area.
B0-BB	176-187	12	IFTLUT2	Bias current fault threshold temperature compensation L.U.T. additional 12 entries.
BC-BF	188-191	4	SCRATCH	OEM scratchpad area
C0-CB	192-203	12	HATLUT2	Bias current high alarm threshold temperature compensation L.U.T. additional 12 entries.
CC-CF	204-207	4	SCRATCH	OEM scratchpad area
D0-DD	208-221	14	RXLUTSEG	RXPWR calibration segments delimiters. Each of the eight segments can have its own slope and offset.
DE-FA	222-250	128	SCRATCH	OEM scratchpad area
FB-FC	251-252	2	POH	Power on hour meter result; read only
FD	253	1	Data Ready Flags	Data ready bits for each measured parameter; read only
FE	254	1	MFG_ID	Manufacturer identification (Micrel = 42 = 2Ah)
FF	255	1	DEV_ID	Device and die revision

**Table 4. OEM Configuration Registers, Serial Address = A6<sub>h</sub>**

## Block Diagram

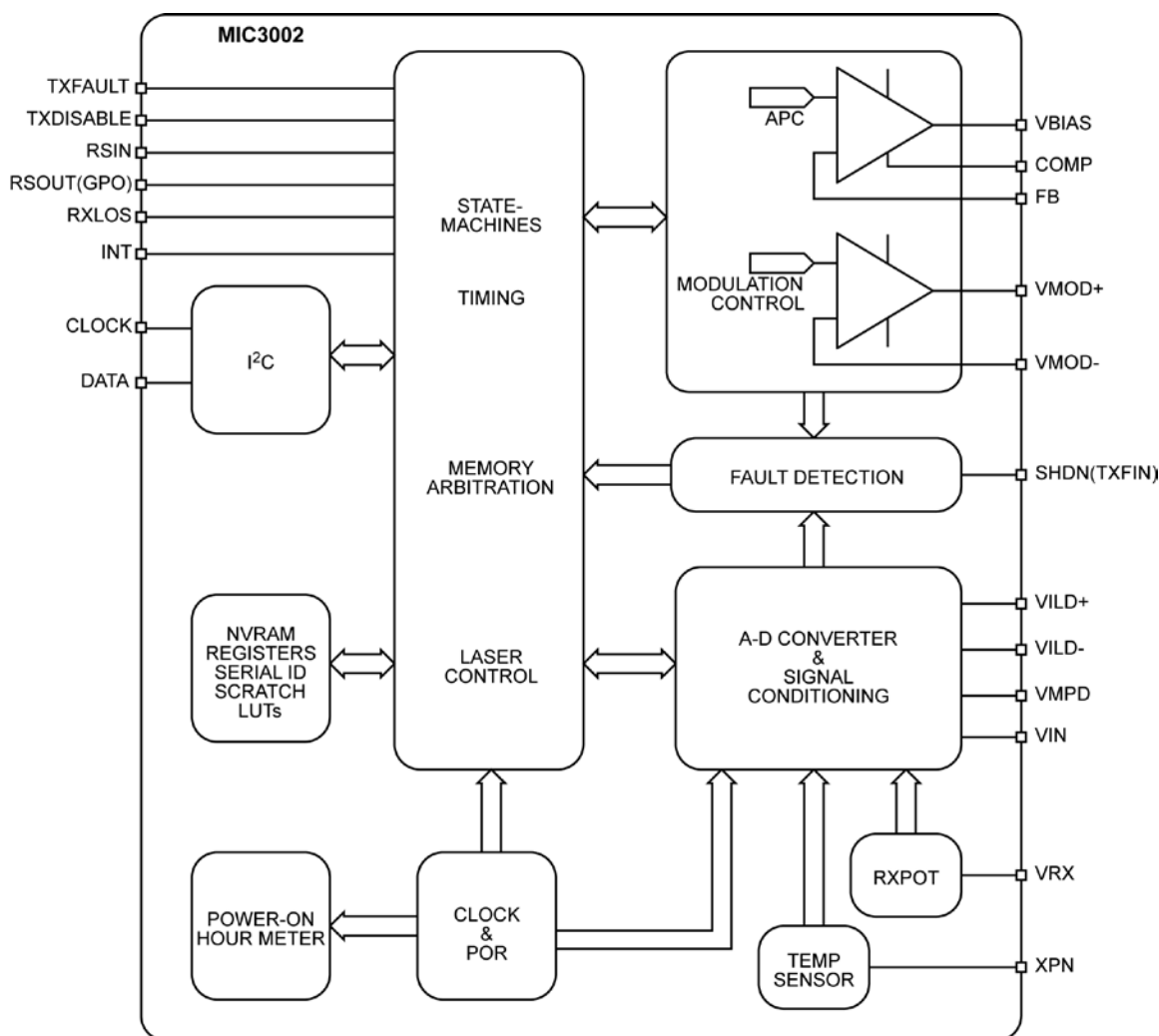


Figure 1. MIC3002 Block Diagram

### Analog-to-Digital Converter/Signal Monitoring

A block diagram of the monitoring circuit is shown below. Each of the five analog parameters monitored by the MIC3002 are sampled in sequence. All five parameters are sampled and the results updated within the  $t_{\text{CONV}}$  internal given in the “Electrical Characteristics” section. In OEM<sub>r</sub> Mode, the channel that is normally used to measure  $V_{\text{IN}}$  may be assigned to measure the level of the  $V_{\text{DDA}}$  pin or one of five other nodes. This provides a kind of analog loopback for debug and test purposes. The  $V_{\text{AUX}}$  bits in OEMCFG0 control which voltage source is being sampled. The various  $V_{\text{AUX}}$  channels are level-shifted differently depending on the signal source, resulting in different LSB values and signal ranges. See Table 5.

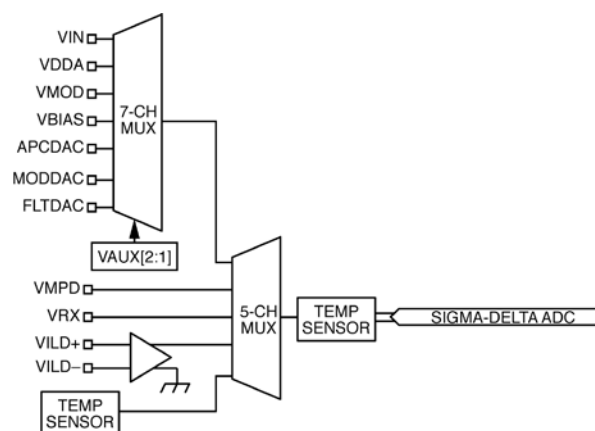


Figure 2. Analog-to-Digital Converter Block Diagram

Channel	ADC Resolution (bits)	Conditions	Input Range (V)	LSB <sup>(1)</sup>
TEMP	8 or 9		N/A	1°C or 0.5°C
VAUX	8	See Table 6		
VMPD	8	GAIN = 0; BIASREF = 0	GNDA - V <sub>REF</sub>	4.77mV
		GAIN = 0; BIASREF = 1	V <sub>DDA</sub> - (V <sub>DDA</sub> - V <sub>REF</sub> )	
		GAIN = 1; BIASREF = 0	GNDA - V <sub>REF</sub> /4	1.17mV
		GAIN = 1; BIASREF = 1	V <sub>DDA</sub> - (V <sub>DDA</sub> - V <sub>REF</sub> ) <sup>/4</sup>	
VILD	8	VILD- = VDDA	V <sub>DDA</sub> - (V <sub>DDA</sub> - V <sub>REF</sub> )	4.77mV
		VILD- = GNDA	GNDA - V <sub>REF</sub>	
VRX	12	RXPOT = 00	0 - V <sub>REF</sub>	0.298mV

Table 5. A/D Input Signal Ranges and Resolutions

**Note:**

1. Assumes typical V<sub>REF</sub> value of 1.22V.

Channel	VAUX [2:0]	Input Range (V)	LSB <sup>(1)</sup> (mV)
V <sub>IN</sub>	000 = 00 <sub>h</sub>	0.5V to 5.5V	25.6mV
V <sub>DDA</sub>	0001 = 01 <sub>h</sub>	0.5V to 5.5V	25.6mV
V <sub>BIAS</sub>	010 = 02 <sub>h</sub>	0.5V to 5.5V	25.6mV
V <sub>MOD</sub>	011 = 03 <sub>h</sub>	0.5V to 5.5V	25.6mV
APCDAC	100 = 04 <sub>h</sub>	0V to V <sub>REF</sub>	4.77mV
MODDAC	101 = 05 <sub>h</sub>	0V to V <sub>REF</sub>	4.77mV
FLTDAC	110 = 06 <sub>h</sub>	0V to V <sub>REF</sub>	4.77mV

Table 6. V<sub>AUX</sub> Input Signal Ranges and Resolutions**Note:**

1. Assumes typical V<sub>REF</sub> value of 1.22V.

**Temperature Reading Compensation**

The sensed temperature by the MIC3002 can be temperature compensated and converted to the optical module case temperature to be monitored or used for modulation and other parameters (L.U.T.s). There are 39 entries (bytes) at address A6: 96-134 (60-86h) where the OEM can enter the temperature difference between the chip (sensed) temperature and the measured module case temperature over the operating temperature range. Table 7 shows the correspondence between the entries and temperature intervals.

The resolution of this table is 0.5°C/bit. The number entered should be twice the temperature difference. For example if the chip-case temperature difference is 5°C, the value to be entered should be 2x5=10.

Entry	Address	Temperature Range
0	A6: 96 (60h)	$t \leq -45\text{ }^{\circ}\text{C}$
1	A6: 97 (61h)	$-44\text{ }^{\circ}\text{C} \leq t \leq -41\text{ }^{\circ}\text{C}$
2	A6: 98 (62h)	$-40\text{ }^{\circ}\text{C} \leq t \leq -37\text{ }^{\circ}\text{C}$
.....		
36	A6: 97 (61h)	$96\text{ }^{\circ}\text{C} \leq t \leq 99\text{ }^{\circ}\text{C}$
37	A6: 97 (61h)	$100 \leq t \leq 103\text{ }^{\circ}\text{C}$
38	A6: 134 (86h)	$t \geq 104\text{ }^{\circ}\text{C}$

Table 7. L.U.T. for Temperature Reading Compensation

**Alarms and Warnings Interrupt Source Masking**

Alarms and warnings set the flags and Interrupt when they are asserted if they are not masked (default). If an alarm or warning is masked, it will not set the Interrupt.

Table 8 shows the locations of the masking bits. The warning or alarm is masked if the corresponding bit is set to 1.

Serial Address A2h		Default Value	Description
Byte	Bit		
248	7	0	Masking bit for Temp High Alarm interrupt source
	6	0	Masking bit for Temp Low Alarm interrupt source
	5	0	Masking bit for Voltage High Alarm interrupt source
	4	0	Masking bit for Voltage Low Alarm interrupt source
	3	0	Masking bit for Bias High Alarm interrupt source
	2	0	Masking bit for Bias Low Alarm interrupt source
	1	0	Masking bit for TX Power High Alarm interrupt source
	0	0	Masking bit for TX Power Low Alarm interrupt source
249	7	0	Masking bit for RX Power High Alarm interrupt source
	6	1	Masking bit for RX Power Low Alarm interrupt source
	5	Reserved	
	4	Reserved	
	3	Reserved	
	2	Reserved	
	1	Reserved	
	0	Reserved	

Table 8. Alarms Interrupt Sources Masking Bits

Serial Address A2h		Default Value	Description
Byte	Bit		
250	7	0	Masking bit for Temp High Warning interrupt source
	6	0	Masking bit for Temp Low Warning interrupt source
	5	0	Masking bit for Voltage High Warning interrupt source
	4	0	Masking bit for Voltage Low Warning interrupt source
	3	0	Masking bit for Bias High Warning interrupt source
	2	0	Masking bit for Bias Low Warning interrupt source
	1	0	Masking bit for TX Power High Warning interrupt source
	0	0	Masking bit for TX Power Low Warning interrupt source
251	7	0	Masking bit for RX Power High Warning interrupt source
	6	1	Masking bit for RX Power Low Warning interrupt source
	5	Reserved	
	4	Reserved	
	3	Reserved	
	2	Reserved	
	1	Reserved	
	0	Reserved	

Table 9. Warnings Interrupt Sources Masking Bits

### Alarms and Warnings as TXFAULT Source

Alarms and warnings are not sources for TXFAULT with the default setting. To set alarms as a TXFAULT source set OEMCFG4 bit 6 to 1. To set warnings as a TXFAULT, source set OEMCFG4 bit 7 to 1. The alarms and warnings TXFAULT sources can be masked individually in the same way shown in Tables 7 and 8.

### Alarms and Warnings Latch

Alarms and warnings are latched with the default setting, i.e., the flags once asserted remain ON until the register is read or TXDSABLE is toggled. If OEMCFG4 bit 5 is set to 1, the warnings are not latched and will be set and reset with the warning condition. Reading the register or toggling TXDISABLE will clear the flag. If OEMCFG4 bit 4 is set to 1, the alarms are not latched and will be set and reset with the alarm condition. Reading the register or toggling TXDISABLE will clear the flag.

### SMBus Multipart Support

If more than one MIC3002 device shares the same serial interface and multipart mode is selected on them (OEMCFG5 bit 3 = 1), then pin 7 and pin 20 become SMBus address bits 3 and 4 respectively. Therefore, the parts should have a different setting on those pins to create four address combinations based upon pin 7 and pin 20 state, (00, 01, 10, 11) where 0 is a pull down to GND and 1 is a pull up to VCC. The parts come from the factory with the same address (A0) and multipart mode OFF (OEMCFG5 bit 3 = 0). After power up, write 1 to OEMCFG5 bit 3 to turn ON multipart mode, which is done to all parts at the same time since they all respond to serial address A0 at this point. With multipart mode ON, the parts have different addresses based on the states of pins 7 and 20. Another option is to access each part individually, set their single mode address in OEMCFG2 bits [4-7] to different values and then turn OFF multipart mode to return to normal mode where the parts have new different address.

### Calibration Modes

The default mode of calibration in the MIC3002 is external calibration, for which INTCAL bit (bit 0 in OEMCF3 register) is set to 0. The internal calibration mode is selected by setting INTCAL bit to 1.

### A/ External Calibration

The voltage and temperature values returned by the MIC3002's A/D converter are internally calibrated. The binary values of TEMPh:TEMPI and VOLTh:VOLTl are in the format called for by SFF-8472 under Internal Calibration.

SFF-8472 calls for a set of calibration constants to be stored by the transceiver OEM at specific non-volatile memory locations; refer to SFF-8472 specifications for memory map of calibration coefficient. The MIC3002 provides the non-volatile memory required for the storage of these constants. The Digital Diagnostic Monitoring Interface specification should be consulted for full details. Slopes and offsets are stored for use with voltage, temperature, bias current, and transmitted power measurements. Coefficients for a fourth-order polynomial are provided for use with received power measurements. The host system can retrieve these constants and use them to process the measured data.

#### Voltage

The voltage values returned by the MIC3002's A/D converter are internally calibrated. The binary values of VOLTh:VOLTl are in the format called for by SFF-8472 under Internal Calibration. Since VINh:VINl requires no processing, the corresponding slope should be set to one and the offset to zero.

#### Temperature

The temperature values returned by the MIC3002's A/D converter are internally calibrated. The binary values of TEMPh:TEMPI are in the format called for by SFF-8472 under Internal Calibration.

#### Bias Current

Bias current is sensed via an external sense resistor as a voltage appearing between VILD+ and VILD-. The value returned by the A/D is therefore a voltage analogous to bias current. Bias current, IBIAS, is simply  $V_{VILD}/R_{SENSE}$ . The binary value in IBIASh (IBIASl is always zero) is related to bias current by:

$$I_{BIAS} = \frac{(0.300V) \left( \frac{IBIASh}{256} \right)}{R_{SENSE}} \quad (1)$$

The value of the least significant bit (LSB) of IBIASh is given by:

$$LSB(IBIASh) = \frac{0.300V}{256 \times R_{SENSE}} \text{ Amps} = \frac{300mV}{256 \times R_{SENSE}} \text{ mA} = \frac{1171.9}{R_{SENSE}} \mu A \quad (2)$$

Per SFF-8472, the value of the bias current LSB is  $2\mu A$ . The conversion factor, "slope", needed is therefore:

$$\text{Slope} = \frac{1171.9\mu A}{512\mu A \times R_{SENSE}} = 2.289 + R_{SENSE}$$

The tolerance of the sense resistor directly impacts the accuracy of the bias current measurement. It is recommended that the sense resistor chosen be 1% accurate or better. The offset correction, if needed, can be determined by shutting down the laser, i.e., asserting TXDISABLE, and measuring the bias current. Any non-zero result gives the offset required. The offset will be equal and opposite to the result of the "zero current" measurement.

#### TX Power

Transmit power is sensed via a resistor carrying the monitor photodiode current. In most applications, the signal at VMPD will be feedback voltage on FB. The VMPD voltage may be measured relative to GND or  $V_{DDA}$  depending on the setting of the BIASREF bit in OEMCFG1. The value returned by the A/D is therefore a voltage analogous to transmit power. The binary value in TXOPh (TXOPl is always zero) is related to transmit power by:

$$P_{TX}(mW) = \frac{K \times VREF \left( \frac{TXOPh}{256} \right)}{R_{SENSE}} = \frac{K \times (1220mV) \left( \frac{TXOPh}{256} \right)}{R_{SENSE}} \\ = \frac{K \times 4.7656 \times TXOPh}{R_{SENSE}} mW \quad (3)$$

For a given implementation, the value of  $R_{SENSE}$  is known. It is either the value of the external resistor or the chosen value of RFB used in the application. The constant, K, will likely have to be determined through experimentation or closed-loop calibration, as it depends on the monitoring photodiode responsivity and coupling efficiency.

It should be noted that the APC circuit acts to hold the transmitted power constant. The value of transmit power reported by the circuit should only vary by a small amount as long as APC is functioning correctly.

**RX Power**

Received power is sensed as a voltage appearing at VRX. It is assumed that this voltage is generated by a sense resistor carrying the receiver photodiode current or by the RSSI circuit of the receiver. The value returned by the A/D is therefore a voltage analogous to received power. The binary values in RXOPh and RXOPl are related to receive power by:

$$RX(mW) = K \times VREF \times (256 \times RXOPh + RXOPl/16) / 65536 \quad (4)$$

For a given implementation, the constant, K, will likely have to be determined through experimentation or closed-loop calibration, as it depends upon the gain and efficiencies of the receiver. In SFF-8472 implementations, the external calibration constants can describe up to a fourth-order polynomial in case K is nonlinear.

**B/ Internal Calibration**

If the INTCAL bit in OEMCFG3 is set to 1 (internal calibration selected), the MIC3002 will process each piece of data coming out of the A/D converter before storing the result in memory. Linear slope/offset correction will be applied on a per-channel basis to the measured values for voltage, bias current, TX power, and RX power. Only compensation is applied to temperature.

The user must store the appropriate slope/offset parameters in memory at the time of transceiver calibration. In the case of RX power, a look-up table is provided that implements eight-segment piecewise-linear correction. This correction may be performed as a compensation of the receiver non-linearity over receive power level. If static slope/offset correction for RX power is desired, the eight coefficient sets can simply be made the same. The memory maps for these coefficients are shown in Tables 11 and 12. The user must enter the seven delimiters of the intervals that fit better the receiver response. The diagram in Figure 3 shows the link between the delimiters and the sets of slopes/offsets.

The slopes allow for the correction of gain errors. Each slope coefficient is an unsigned, sixteen-bit, fixed-point binary number in the format:

[mmmmmmmm.Illlllll], where m is a data bit (5)  
in the most-significant byte and l is a data  
bit in the least significant byte

Slopes are always positive. The binary point is in between the two bytes, i.e., between bits 7 and 8. This provides a numerical range of 1/256 (0.00391) to 255.997 in steps of 1/256. The most significant byte is always stored in memory at the lower numerical address.

The offsets correct for constant errors in the measured data. Each offset is a signed, sixteen-bit, fixed-point binary number. The bit-weights of the offsets are the same as that of the final results. The sixteen-bit offsets provide a numerical range of –32768 to +32767 for voltage, bias current, transmit power, and receive power. The numerical range for the temperature offset is –32513 (–128°) to +32512 (+127°) in increments of 256 (1°). The format for offsets is:

[SmmmmmmmlIlllllll], where S is the sign bit (6)  
(0 = positive, 1 = negative), m is a data bit in  
the most-significant byte and l is a data bit in  
the least significant byte

The most significant byte is always stored in memory at the lower numerical address.

Calibration of voltage, bias current, and TX power are performed using the following calculation:

$$RESULTn = ADC\_RESULTn \times SLOPEN + OFFSETn \quad (7)$$

Calibration of RX power is performed using the following calculation:

$$RESULT = ADC\_RESULT \times SLOPE(m) + OFFSET(m) \quad (9)$$

where m represents one of the eight linearization intervals corresponding to the RX power level.

The results of these calculations are rounded to sixteen bits in length. If the seventeenth most significant bit is a one, the result is rounded up to the next higher value. If the seventeenth most significant bit is zero, the upper sixteen bits remain unchanged. The bit-weights of the offsets are the same as that of the final results. For SFF-8472 compatible applications, these bit-weights are given in Table 10.

Parameter	Magnitude of LSB
Voltage	100μV
Bias Current	2μA
TX Power	0.1μW
RX Power	0.1μW

**Table 10. LSB Values of Offset Coefficients**



Address(s)		Field Size	Name	Description
HEX	DEC			
48-49	72-73	2	RESERVED	Reserved. (There is no slope for temperature.) Do not write; reads undefined.
4A-4B	74-75	2	RESERVED	Reserved. (There is no offset for temperature.) Do not write; reads undefined.
4C-4D	76-77	2	VSLPh:VSLPI	Voltage slope; unsigned fixed-point; MSB is at lower physical address.
4E-4F	78-79	2	VOFFh:VOFFI	Voltage offset; signed fixed point; MSB is at lower physical address.
50-51	80-81	2	ISLPh:ISLPI	Bias current slope; unsigned fixed-point; MSB is at lower physical address.
52-53	82-83	2	IOFFh:IOFFI	Bias current offset; signed fixed point; MSB is at lower physical address.
54-55	84-85	2	TXSLPh:TXSLPI	TX power slope; unsigned fixed-point; MSB is at lower physical address.
56-57	86-87	2	TXOFFh:TXOFFI	TX power offset; signed fixed point; MSB is at lower physical address.

Table 11. Internal Calibration Coefficient Memory Map – Part I

Address(s)		Field Size	Name	Description
HEX	DEC			
28-29	40-41	2	RXSLP0h:RXSLP0I	RX power slope 0; unsigned fixed-point; MSB is at lower physical address.
2A-2B	42-43	2	RXOFF0h:RXOFF0I	RX power offset 0; signed twos-complement; MSB is at lower physical address.
2C-2D	44-45	2	RXSLP1h:RXSLP1I	RX power slope 1; unsigned fixed-point; MSB is at lower physical address.
2E-2F	46-47	2	RXOFF1h:RXOFF1I	RX power offset 1; signed twos-complement; MSB is at lower physical address.
30-31	48-49	2	RXSLP2h:RXSLP2I	RX power slope 2; unsigned fixed-point; MSB is at lower physical address.
32-33	50-51	2	RXOFF2h:RXOFF2I	RX power offset 2; signed twos-complement; MSB is at lower physical address.
34-35	52-53	2	RXSLP3h:RXSLP3I	RX power slope 3; unsigned fixed-point; MSB is at lower physical address.
36-37	54-55	2	RXOFF3h:RXOFF3I	RX power offset 3; signed twos-complement; MSB is at lower physical address.
38-39	56-57	2	RXSLP4h:RXSLP4I	RX power slope 4; unsigned fixed-point; MSB is at lower physical address.
3A-3B	58-59	2	RXOFF4h:RXOFF4I	RX power offset 4; signed twos-complement; MSB is at lower physical address.
3C-3D	60-61	2	RXSLP5h:RXSLP5I	RX power slope 5; unsigned fixed-point; MSB is at lower physical address.
3E-3F	62-63	2	RXOFF5h:RXOFF5I	RX power offset 5; signed twos-complement; MSB is at lower physical address.
40-41	64-65	2	RXSLP6h:RXSLP6I	RX power slope 6; unsigned fixed-point; MSB is at lower physical address.
42-43	66-67	2	RXOFF6h:RXOFF6I	RX power offset 6; signed twos-complement; MSB is at lower physical address.
44-45	68-69	2	RXSLP7h:RXSLP7I	RX power slope 7; signed twos-complement; MSB is at lower physical address.
46-47	70-71	2	RXOFF7h:RXOFF7I	RX power offset 7; signed fixed-point; MSB is at lower physical address.

Table 12. Internal Calibration Coefficient Memory Map – Part II



Address(s)		Name		Delimiter	Address(s)	
HEX	DEC				HEX	DEC
28-29	40-41	RXSLP0h: RXSLP0I	← RXPWR ≤ Delimiter #1	Delimiter #1	D0-D1	208-209
2A-2B	42-43	RXOFF0h: RXOFF0I				
2C-2D	44-45	RXSLP1h: RXSLP1I	← Delimiter #1 < RXPWR ≤ Delimiter #2	Delimiter #2	D2-D3	210-211
2E-2F	46-47	RXOFF1h: RXOFF1I				
30-31	48-49	RXSLP2h: RXSLP2I	← Delimiter #2 < RXPWR ≤ Delimiter #3	Delimiter #3	D4-D5	212-213
32-33	50-51	RXOFF2h: RXOFF2I				
34-35	52-53	RXSLP3h: RXSLP3I	← Delimiter #3 < RXPWR ≤ Delimiter #4	Delimiter #4	D6-D7	214-215
36-37	54-55	RXOFF3h: RXOFF3I				
38-39	56-57	RXSLP4h: RXSLP4I	← Delimiter #4 < RXPWR ≤ Delimiter #5	Delimiter #5	D8-D9	216-217
3A-3B	58-59	RXOFF4h: RXOFF4I				
3C-3D	60-61	RXSLP5h: RXSLP5I	← Delimiter #5 < RXPWR ≤ Delimiter #6	Delimiter #6	DA-DB	218-219
3E-3F	62-63	RXOFF5h: RXOFF5I				
40-41	64-65	RXSLP6h: RXSLP6I	← Delimiter #6 < RXPWR ≤ Delimiter #7	Delimiter #7	DC-DD	220-221
42-43	66-67	RXOFF6h: RXOFF6I				
44-45	68-69	RXSLP7h: RXSLP7I	← RXPWR > Delimiter #7			
46-47	70-71	RXOFF7h: RXOFF7I				

Figure 3. Internal Calibration RX Power Linear Approximation

### Temperature Offset

In both internal and external calibration, the temperature offset is set in the temperature reading compensation LUT (see subsection above). Bit 5 in OMCFG5 (A6:1Ah) must be set to 1 in order to enable temperature reading compensation. Since the resolution of that L.U.T. is 0.5°C, the entered value should be twice the real value. For example, if the content of the L.U.T. is 0 for all the entries and the offset is 5°C, then the offset value to be added to the entries content is 10. The new content of the L.U.T. entries will be 0+10=10.

### C/ ADC Result Registers Reading

The ADC result registers should be read as 16-bit registers under internal calibration while under external calibration they should be read as 8-bit or 16-bit registers at the MSB address. For example, TX power should be read under internal calibration as 16 bits at address A2<sub>h</sub>: 66–67 and under external calibration as 8 bits at address A2<sub>h</sub>: 66<sub>h</sub>. 9-bit temperature results and 12-bit receive power results should always be read as 16-bit quantities.

### RXPOT

A programmable, non-volatile digitally controlled potentiometer is provided for adjusting the gain of the receive power measurement signal chain in the analog domain. Five bits in the RXPOT register are used to set and adjust the position of potentiometer. RXPOT functions as a programmable divider or attenuator. It is adjustable in steps from 1:1 (no divider action) down to 1/32 in steps of 1/32. If RXPOT is set to zero, then the divider is bypassed completely. There will be no scaling of the input signal, and the resistor network will be disconnected from the VRX pin.

At all other settings of RXPOT, there will be a 32kΩ (typical) load seen on VRX.

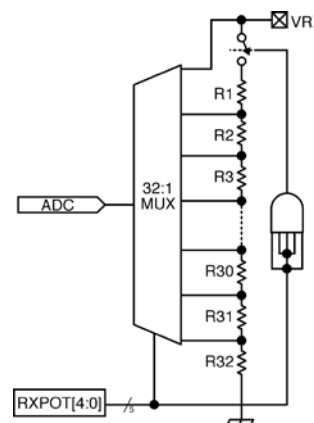


Figure 4. RXPOT Block Diagram

### Laser Diode Bias Control

The MIC3002 can be configured to generate a constant bias current using electrical feedback, or regulate average transmitted optical power using a feedback signal from a monitor photodiode, refer to Figure 5. An operational amplifier is used to control laser bias current via the V<sub>BIAS</sub> output. The V<sub>BIAS</sub> pin can drive a maximum of ±10mA. An external bipolar transistor provides current gain. The polarity of the op amp's output is programmable BIASREF in OEMCFG1 in order to accommodate either NPN or PNP transistors that drive common anode and common cathode laser, respectively. Additionally, the polarity of the feedback signal is programmable for use with either common-emitter or emitter-follower transistor circuits.

Furthermore, the reference level for the APC circuit is selectable to accommodate electrical, i.e., current feedback, or optical feedback via a monitor photodiode. Finally, any one of seven different internal feedback resistors can be selected. This internal resistor can be used alone or in parallel with an external resistor. This wide range of adjustability (50:1) accommodates a wide range of photodiode current, i.e., wide range of transmitter output power. The APC operating point can be kept near the mid-scale value of the APC DAC, insuring maximum SNR, maximum effective resolution for digital diagnostics, and the widest possible DAC adjustment range for temperature compensation, etc. See Figure 6.

The APCCAL bit in OEMCAL0 is used to turn the APC function on and off. It will be turned off in the MIC3002's default state as shipped from the factory. When APC is on, the value in the selected APCSETx register is added to the signed value taken from the APC look-up table and loaded into the  $V_{BIAS}$  DAC. When APC is off, the  $V_{BIAS}$  DAC may be written directly via the  $V_{BIAS}$  register, bypassing the look-up table entirely. This provides direct control of the laser diode bias during setup and calibration. In either case, the  $V_{BIAS}$  DAC setting is reported in the APCDAC register. The APCCFG bits determine the DACs response to higher or lower numeric values.

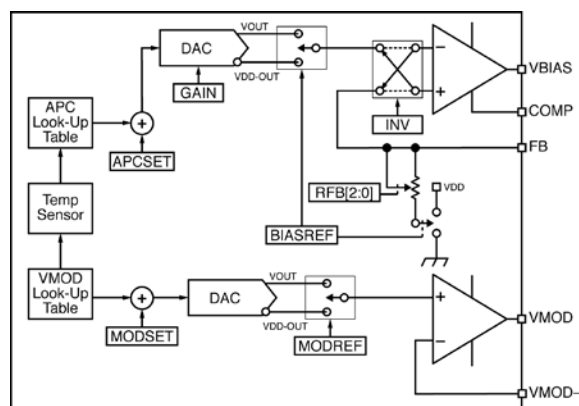


Figure 5. MIC3002 APC and Modulation Control Block Diagram

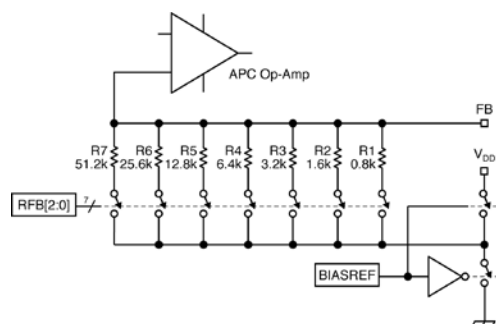


Figure 6. Programmable Feedback Resistor

## Laser Modulation Control

As shown in Figure 5, a temperature-compensated DAC is provided to set and control the laser modulation current via an external laser driver circuit. MODREF in OEMCFG0 selects whether the  $V_{MOD}$  DAC output swings up from ground or down from  $V_{DD}$ . If the laser driver requires a voltage input to set the modulation current, the MIC3002's  $V_{MOD}$  output can drive it directly. If a current input is required, a fixed resistor can be used between the driver and the  $V_{MOD}$  output. Several different configurations are possible as shown in Figure 8.

When APC is on, i.e., the APCCAL bit in OEMCAL0 is set to 0, the value corresponding to the current temperature is taken from the MODLUT look-up table, added to MODSET, and loaded into the  $V_{MOD}$  DAC. When APC is off, the value in  $V_{MOD}$  is loaded directly into the  $V_{MOD}$  DAC, bypassing the look-up table entirely. This provides for direct modulation control for setup and calibration. The MODREF bit determines the DACs response to higher or lower numeric values.

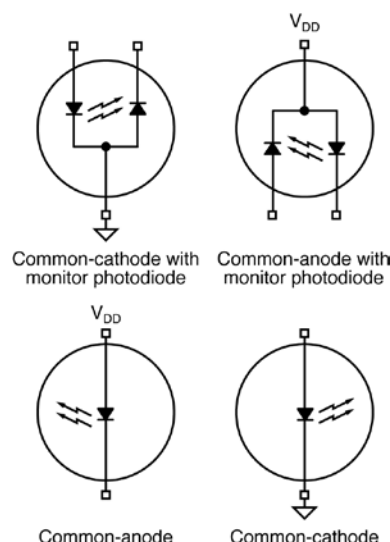
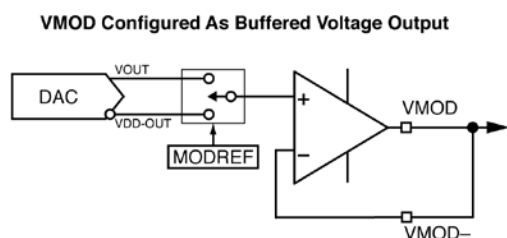
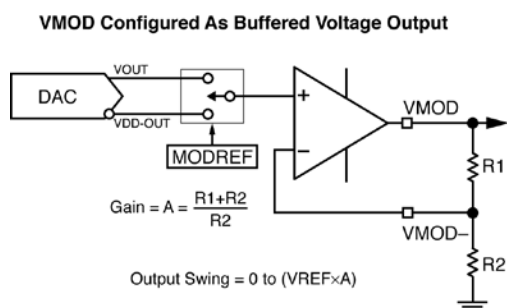


Figure 7. Transmitter Configurations Supported by MIC3002



Output Swing = 0 to V<sub>REF</sub> or V<sub>DDA</sub> to (V<sub>DDA</sub> - V<sub>REF</sub>)



**Figure 8. V<sub>MOD</sub> Configured as Voltage Output with Gain**

### Power ON and Laser Start-Up

When power is applied, then the MIC3002 initializes its internal registers and state machine. This process takes  $t_{POR}$ , about 50ms. Following  $t_{POR}$ , analog-to-digital conversions begin, serial communication is possible, and the POR bit and data ready bits may be polled. The first set of analog data will be available  $t_{CONV}$  after  $t_{POR}$ . MIC3002s are shipped from the factory with the output enable bit, OE, set to zero, off. The MIC3002's power-up default state, therefore, is APC off, V<sub>BIAS</sub>, V<sub>MOD</sub>, and SHDN outputs disabled. V<sub>BIAS</sub>, V<sub>MOD</sub>, and SHDN will be floating (high impedance) and the laser diode, if connected, will be off. Once the device is incorporated into a transceiver and properly configured, then the shutdown states of SHDN, V<sub>BIAS</sub> and V<sub>MOD</sub> will be determined by the state of the APC configuration and OE bits. Tables 13, 14, and 15 illustrate the shutdown states of the various laser control outputs versus the control bits.

Configuration Bits		Shutdown State
OE	SPOL	SHDN
0	Don't Care	Hi-Z
1	0	≈GND
1	1	≈V <sub>DD</sub>

**Table 13. Shutdown State of SHDN vs. Configuration Bits**

Configuration Bits			V <sub>BIAS</sub> Shutdown State
OE	INV	BIASREF	V <sub>BIAS</sub>
0	Don't Care	Don't Care	Hi-Z
1	Don't Care	0	≈GND
1	Don't Care	1	≈V <sub>DD</sub>

**Table 14. Shutdown State of V<sub>BIAS</sub> vs. Configuration Bits**

Configuration Bits		V <sub>MOD</sub> Shutdown State
OE	MODREF	V <sub>MOD</sub>
0	Don't Care	Hi-Z
1	0	≈GND
1	1	≈V <sub>DD</sub>

**Table 15. Shutdown State of V<sub>MOD</sub> vs. Configuration Bits**

In order to facilitate hot-plugging, the laser diode is not turned on until  $t_{INIT2}$  after Power-On. Following  $t_{INIT2}$ , and assuming TXDISABLE is not asserted, the DACs will be loaded with their initial values. Since  $t_{CONV}$  is much less than  $t_{INIT2}$ , the first set of analog data, including temperature, is available at  $t_{INIT2}$ . Temperature compensation will be applied to the DAC values if enabled. APC will begin if OE is asserted. (If the output enable bit, OE, is not set, the V<sub>MOD</sub>, V<sub>BIAS</sub>, and SHDN outputs will float indefinitely.) Figure 9 shows the power-up timing of the MIC3002. If TXDISABLE is asserted at power-up, the V<sub>MOD</sub> and V<sub>BIAS</sub> outputs will stay in their shutdown states following MIC3002 initialization. A/D conversions will begin, but the laser will remain off.

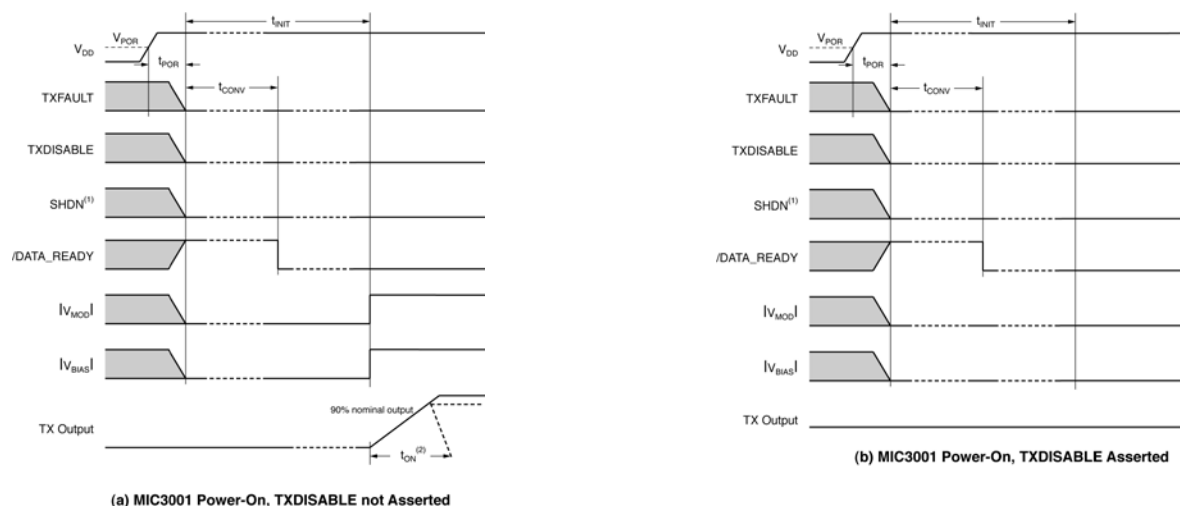


Figure 9. MIC3002 Power-On Timing (OE = 1)

### Fault Comparators

In addition to detecting and reporting the events specified in SFF-8472, the MIC3002 also monitors five fault conditions: inadequate supply voltage, thermal diode faults, excessive bias current, excessive transmit power, and APC op-amp saturation. Comparators monitor these parameters in order to respond quickly to fault conditions that could indicate link failure or safety issues, see Figure 10. When a fault is detected, the laser is shut down and TXFAULT is asserted. Each fault source may be independently disabled using the FLTMSK register. FLTMSK is non-volatile, allowing faults to be masked only during calibration and testing or permanently.

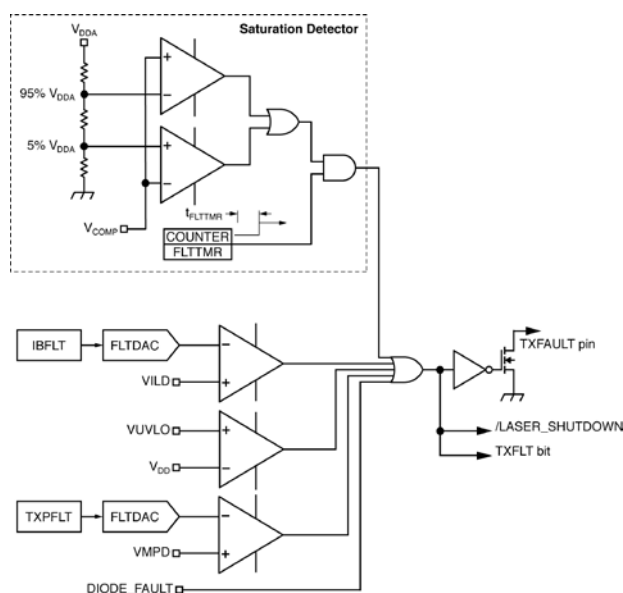


Figure 10. Fault Comparator Logic

Thermal diode faults are detected within the temperature measurement subsystem when an out-of-range signal is detected. A window comparator circuit monitors the voltage on the compensation capacitor to detect APC op-amp saturation (Figure 11). Op-amp saturation indicates that some fault has occurred in the control loop such as loss of feedback. The saturation detector is blanked for a time, tFLTMR, following laser turn-on since the compensation voltage will essentially be zero at turn-on. The FLTMR interval is programmable from 0.5ms to 127ms (typical) in increments of 0.5ms (tFLTMR). Note that a saturation comparator cannot be relied upon to meet certain eye-safety standards that require 100ms response times. This is because the operation of a saturation detector is limited by the loop bandwidth, i.e., the choice of CCOMP. Even if the comparator itself was very fast, it would be subject to the limited slew-rate of the APC op-amp. Only the other fault comparator channels will meet <100ms timing requirements.

The MIC3002 can also except and respond to fault inputs from external devices. See "SHDN and TXFIN" section.

A similar comparator circuit monitors received signal strength and asserts RXLOS when loss-of-signal is detected (Figure 12). RXLOS will be asserted when and if VRX drops below the level programmed in LOSFLT. Hysteresis is implemented such that RXLOS will be de-asserted when VRX subsequently rises above the level programmed in LOSFLTn. The loss-of-signal comparator may be disabled completely by setting the LOSDIS bit in OEMCFG3. Once the LOS comparator is disabled, an external device may drive RXLOS. The state of the RXLOS pin is reported in the CNTRL register regardless of whether it is driven by the internal comparator or by an external device. A programmable digital-to-analog converter provides the comparator reference voltages for monitoring

received signal strength, transmit power, and bias current. Glitches less than 10ms (typical) in length are rejected by the fault comparators. Since laser bias current varies greatly with temperature, there is a temperature compensation look-up table for the bias current fault DAC value.

When a fault condition is detected, the laser will be shutdown immediately and TXFAULT will be asserted. The  $V_{MOD}$ ,  $V_{BIAS}$ , and SHDN if enabled, OEMCFG5-7 is set to 1, outputs will be driven to their shutdown state according to the state of the configuration bits. The shutdown states of  $V_{MOD}$ ,  $V_{BIAS}$ , and SHDN versus the configuration bit settings are shown in Table 13, Table 14, and Table 15.

### SHDN and TXFIN

SHDN and TXFIN are optional functions of pin 7. SHDN is an output function and is designed to drive a redundant safety switch in the laser current path. TXFIN is an input function and serves as an input for fault signals from external devices that must be reported to the host via TXFAULT. The SHDN function is designed for applications in which the MIC3002 is performing all APC and laser management tasks. The TXFIN function is for situations in which an external device such as a laser diode driver IC is performing laser management tasks, including fault detection.

If the TXFIN bit in OEMCFG3 is zero (the default mode), SHDN will be activated anytime the laser is off. Thus, it will be active if 1) TXDISABLE is asserted, 2) STXDIS in CNTRL, is set, or 3) a fault is detected. SHDN is a push-pull logic output. Its polarity is programmable via the SPOL bit in OEMCFG1.

If TXFIN is set to one, pin 7 serves as an input that accepts fault signals from external devices such as laser diode driver ICs. Multiple TXFAULT signals cannot simply be wire-ORed together as they are open-drain and active high. The input polarity is programmable via the TXFPOL bit in OEMCFG3. TXFIN is logically ORed with the MIC3002's internal fault sources to produce TXFAULT and determine the value of the transmit fault bit in CNTRL. See Figure 10.

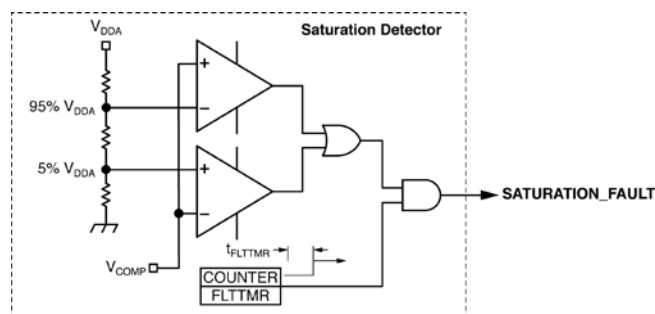


Figure 11. Saturation Detector

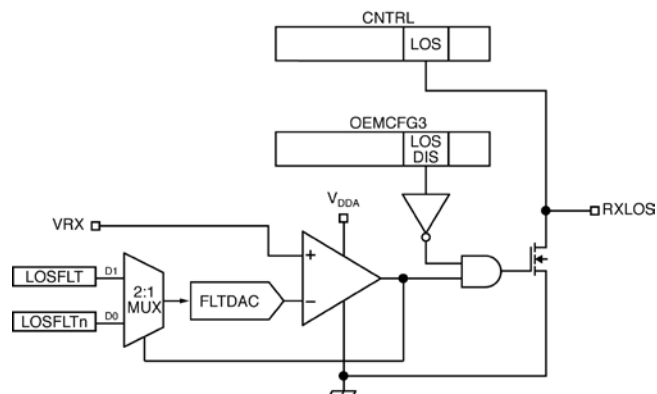


Figure 12. RXLOS Comparator Logic

### Temperature Measurement

The temperature-to-digital converter for both internal and external temperature data is built around a switched current source and an eight-bit/nine-bit analog-to-digital converter. The temperature is calculated by measuring the forward voltage of a diode junction at two different bias current levels. An internal multiplexer directs the current source's output to either an internal or external diode junction. The value of the ZONE bit in OEMCFG1 determines whether readings are taken from the on-chip sensor or from the XPN input. The external PN junction may be embedded in an integrated circuit, or it may be a diode-connected discrete transistor. This data is also used as the input to the temperature compensation look-up tables. Each time temperature is sampled and an updated value acquired, new corrective values for IMOD and the APC setpoint are read from the corresponding tables, added to the set values, and transferred to the DACs.

### Diode Faults

The MIC3002 is designed to respond in a failsafe manner to hardware faults in the temperature sensing circuitry. If the connection to the sensing diode is lost or the sense line is shorted to  $V_{DD}$  or ground, the temperature data reported by the A/D converter will be forced to its full-scale value (+127°C). The diode fault flag, DFLT, will be set in OEMCFG1, TXFAULT will be asserted, and the high temperature alarm and warning flags will be set. The reported temperature will remain +127°C until the fault condition is cleared. Diode faults may be reset by toggling TXDISABLE, as with any other fault. Diode faults will not be detected at power up until the first A/D conversion cycle is completed. Diode faults are not reported while TXDISABLE is asserted.

### Temperature Compensation

Since the performance characteristics of laser diodes and photodiodes change with operating temperature, the



MIC3002 provides a facility for temperature compensation of the A.P.C. loop set-point, laser modulation current, bias current fault comparator threshold, and bias current high alarm flag threshold. Temperature compensation is performed using a look-up table (LUT) that stores values corresponding to each measured temperature over a 150°C span. Four identical tables reside at serial address A4h and A6h as summarized in Table 16. Each table entry is a signed twos complement number that is used as an offset to the parameter being compensated. The default value of all table entries is zero, giving a flat response.

The A/D converter reports a new temperature sample each  $t_{\text{CONV}}$ . This occurs at roughly 10Hz. To prevent temperature oscillation due to thermal or electrical noise, sixteen successive temperature samples are averaged together and used to index the L.U.T.s. Temperature compensation results are therefore updated at  $16 \times t_{\text{CONV}}$  intervals, or about 1.6 seconds. This can be expressed as shown in Equation 10:

$$T_{\text{COMPm}} = \frac{T_n + T_{n+1} + T_{n+2} + \dots + T_{n+15}}{16} \quad (10)$$

Each time an updated average value is acquired, a new offset value for the APC setpoint is read from the corresponding look-up table (see Table 17) and transferred to the APC circuitry. This is illustrated in Equation 11. In a same way, new offset values are taken from similar look-up tables (see Table 18 and Table 19), added to the nominal values and transferred into the modulation and fault comparator DACs. The bias current high alarm threshold is compensated using a fourth look-up table (see Table 20). This compensation happens internally and does not affect any host-accessible registers.

$$\begin{aligned} \text{APCSET}_m &= \text{APCSET}_x + \text{APCLUT}(T_{\text{COMPm}}) & \text{Table\_min} \leq T_{\text{COMPm}} \leq \text{Table\_max} \\ \text{APCSET}_m &= \text{APCSET}_x + \text{APCLUT}(\text{max}) & T_{\text{COMP}} > \text{Table\_max} \\ \text{APCSET}_m &= \text{APCSET}_x + \text{APCLUT}(\text{min}) & T_{\text{COMP}} < \text{Table\_min} \end{aligned} \quad (11)$$

If the measured temperature is greater than the maximum table value, the highest value in each table is used. If the measured temperature is less than the minimum, the minimum value is used. Hysteresis is employed to further enhance noise immunity and prevent oscillation about a table threshold. Each table entry spans two degrees C. The table index will not change unless the new temperature average results in a table index beyond the midpoint of the next entry in either direction. There is therefore 2 to 3°C of hysteresis on temperature compensation changes. The table index will never oscillate due to quantization noise as the hysteresis is much larger than  $\pm 1/2$  LSB.

Serial Address	Byte Addresses	Function
I2CADR+4h	00h–3Fh	APC Look-up Table
	40h–7Fh	I <sub>MOD</sub> Look-up Table
	80h–BFh	IFLT Look-up Table
	C0h–FFh	Bias High Alarm Look-up Table
I2CADR+6h	90h–9Bh	APC Look-up Table (cont.)
	A0h–ABh	I <sub>MOD</sub> Look-up Table (cont.)
	B0h–BBh	IFLT Look-up Table (cont.)
	C0h–CBh	Bias High Alarm Look-up Table (cont.)

**Table 16. Temperature Compensation Look-up Tables**

Serial Address	Register Address	Table Offset	Temperature Offset (°C)
I2CADR+4h	00h	0	≤ -45
	01h	1	-44
			-43
	•	•	•
	•	•	•
	•	•	•
	3Fh	63	80
			81
I2CADR+6h	90h	64	82
			83
	•	•	•
	•	•	•
	9A	74	102
			103
	9B	75	≥ 104

**Table 17. APC Temperature Compensation Look-Up Table**

Serial Address	Register Address	Table Offset	Temperature Offset (°C)
I2CADR+4h	80h		≤ -45
	81h		-44
			-43
	82h		
	•		
	•		
	•		
	8Eh		
I2CADR+6h	8Fh	63	80
			81
	B0	64	82
			83
	•	•	•
	•	•	•
	BA	74	102
			103
	BB	75	≥ 104

**Table 19. I<sub>BIAS</sub> Comparator Temperature Compensation Look-Up Table**

Serial Address	Register Address	Table Offset	Temperature Offset (°C)
I2CADR+4h	40h	0	≤ -45
	41h	1	-44
			-43
	•	•	•
	•	•	•
	•	•	•
	7Fh	63	80
			81
I2CADR+6h	A0	64	82
			83
	•	•	•
	•	•	•
	AA	74	102
			103
	AB	75	≥ 104

**Table 18. V<sub>MOD</sub> Temperature Compensation Look-Up Table**

Serial Address	Register Address	Table Offset	Temperature Offset (°C)
I2CADR+4h	C0h		≤ -45
	C1h		-44
			-43
	C2h		
	•		
	•		
	•		
	FEh		
I2CADR+6h	FFh	63	80
			81
	C0	64	82
			83
	•	•	•
	•	•	•
	CA	74	102
			103

**Table 20. BIAS Current High Alarm Temperature Compensation Table**

The internal state machine calculates a new table index each time a new average temperature value becomes available. This table index is derived from the average temperature value. The table index is then converted into a table address for each of the four look-up tables. These operations can be expressed as:

$$\text{INDEX} = \left\lfloor \frac{T_{\text{AVG}(n)}}{2} \right\rfloor \quad (12)$$

where  $T_{\text{AVG}(n)}$  is the current average temperature; and

$$\text{TABLE\_ADDRESS} = \text{INDEX} + \text{BASE\_ADDRESS}$$

where  $\text{BASE\_ADDRESS}$  is the physical base address of each table, i.e.,  $00_h$ ,  $40_h$ ,  $80_h$ , or  $C0_h$  (tables reside in the  $\text{I2CADR}+4h$  and  $\text{I2CADR}+6h$  pages of memory).

At any given time, the current table index can be read in the  $\text{LUTINDX}$  register.

### Alarms and Warning Flags

There are 20 different conditions that will cause the MIC3002 to set one of the bits in the  $\text{WARNx}$  or  $\text{ALARMx}$  registers. These conditions are listed in Table 22. The less critical of these events generate warning flags by setting a bit in  $\text{WARN0}$  or  $\text{WARN1}$ . The more critical events cause bits to be set in  $\text{ALARM0}$  or  $\text{ALARM1}$ .

An event occurs when any alarm or warning condition becomes true. Each event causes its corresponding status bit in  $\text{ALARM0}$ ,  $\text{ALARM1}$ ,  $\text{WARN0}$ , or  $\text{WARN1}$  to be set. This action cannot be masked by the host. The status bit will remain set until the host reads that particular status register, a power on-off cycle occurs, or the host toggles  $\text{TXDISABLE}$ .

If  $\text{TXDISABLE}$  is asserted at any time during normal operation, A/D conversions continue. The A/D results for all parameters will continue to be reported. All events will be reported in the normal way. If they have not already been individually cleared by read operations, when  $\text{TXDISABLE}$  is de-asserted, all status registers will be cleared.

### Control and Status I/O

The logic for the transceiver control and status I/O is shown schematically in Figure 13. Note that the internal drivers on  $\text{RXLOS}$ ,  $\text{RATE\_SELECT}$ , and  $\text{TXFAULT}$  are all open-drain. These signals may be driven either by the internal logic or external drivers connected to the corresponding MIC3002 pins. In any case, the signal level appearing at the pins of the MIC3002 will be reported in the control register status bits.

Note that the control bits for  $\text{TX\_DISABLE}$  and  $\text{RATE\_SELECT}$  and the status bits for  $\text{TXFAULT}$  and  $\text{RXLOS}$  do not meet the timing requirements as specified in the SFP MSA or the GBIC Specification, revision 5.5 (SFF-8053) for the hardware signals. The speed of the serial interface limits the rate at which these functions can be manipulated and/or reported. The response time for the control and status bits is given in the "Electrical Characteristics" subsection.



Event	Condition	MIC3002 Response
Temperature high alarm	TEMP > TMAX	Set ALARM0[7]
Temperature low alarm	TEMP < TMIN	Set ALARM0[6]
Voltage high alarm	VIN > VMAX	Set ALARM0[5]
Voltage low alarm	VIN < VMIN	Set ALARM0[4]
TX bias high alarm	IBIAS > IBMAX	Set ALARM0[3]
TX bias low alarm	IBIAS < IBMIN	Set ALARM0[2]
TX power high alarm	TXOP > TXMAX	Set ALARM0[1]
TX power low alarm	TXOP < TXMIN	Set ALARM0[0]
RX power high alarm	RXOP > RXMAX	Set ALARM1[7]
RX power low alarm	RXOP < RXMIN	Set ALARM1[6]
Temperature high warning	TEMP > THIGH	Set WARN0[7]
Temperature low warning	TEMP < TLOW	Set WARN0[6]
Voltage high warning	VIN > VHIGH	Set WARN0[5]
Voltage low warning	VIN < VLOW	Set WARN0[4]
TX bias high warning	IBIAS > IBHIGH	Set WARN0[3]
TX bias low warning	IBIAS < IBLOW	Set WARN0[2]
TX power high warning	TXOP > TXHIGH	Set WARN0[1]
TX power low warning	TXOP < TXLOW	Set WARN0[0]
RX power high warning	RXOP > RXHIGH	Set WARN1[7]
RX power low warning	RXOP < RXLOW	Set WARN1[6]

Table 22. MIC3002 Events

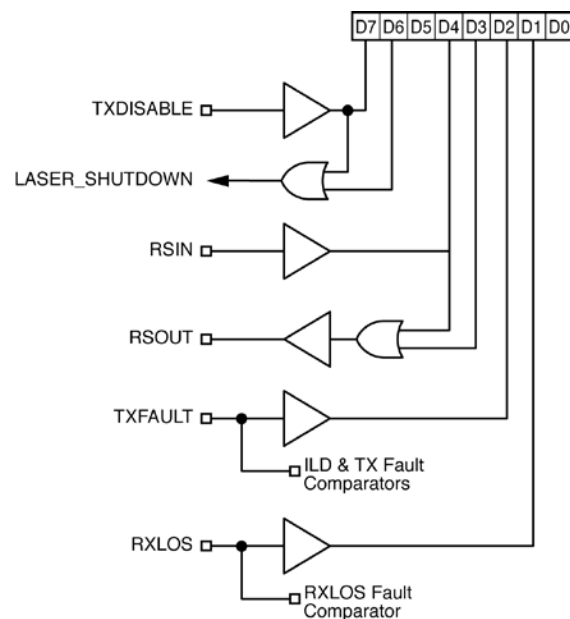
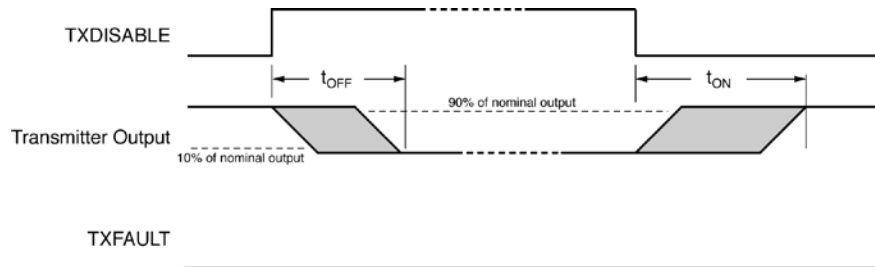


Figure 13. Control and Status I/O Logic

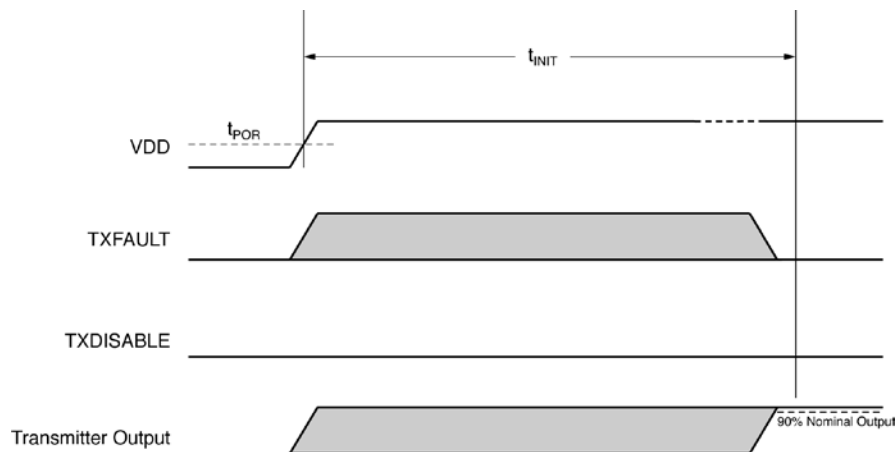
## System Timing

The timing specifications for MIC3002 control and status

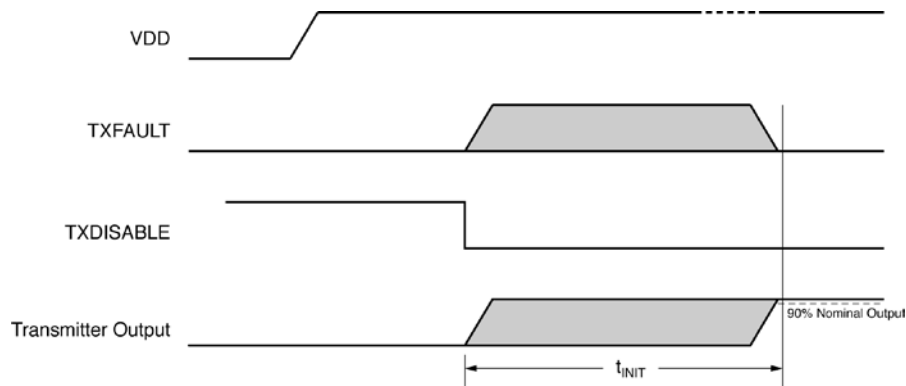
I/O are given in the “Electrical Characteristics” subsection.



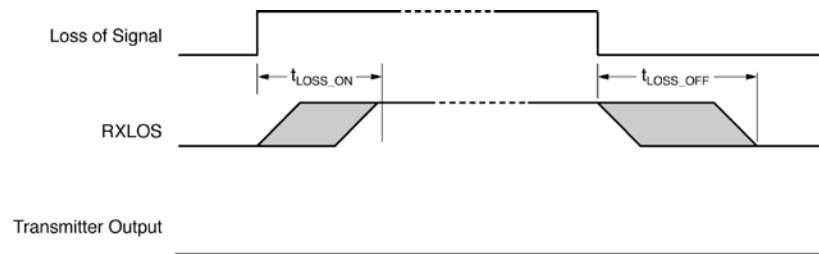
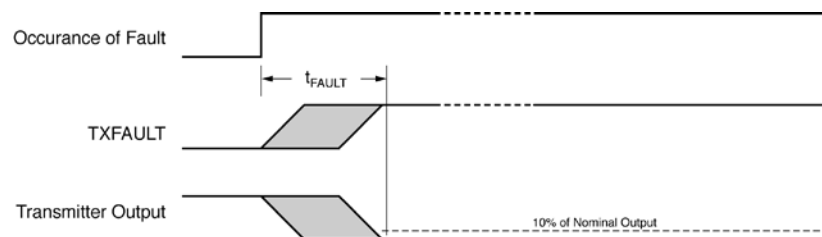
**Figure 14. Transmitter ON-OFF Timing**



**Figure 15. Initialization Timing with TXDISABLE Asserted**



**Figure 16. Initialization Timing with TXDISABLE Not Asserted**

**Figure 17. Loss-of-Signal (LOS) Timing****Figure 18. Transmit Fault Timing**

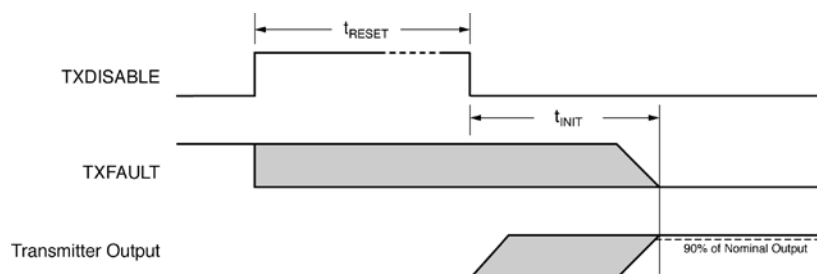


Figure 19. Successfully Clearing a Fault Condition

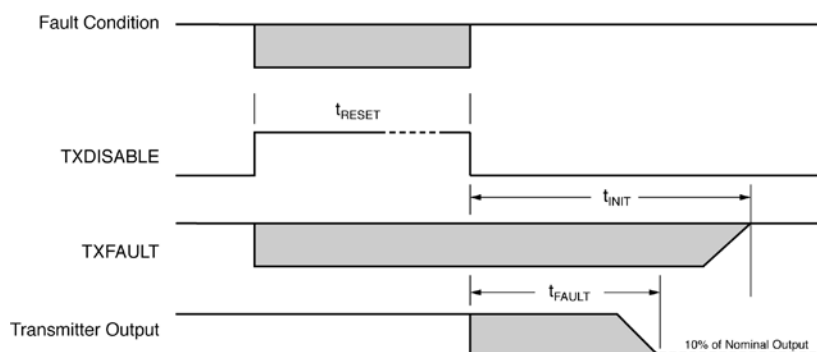


Figure 20. Unsuccessful Attempt to Clear a Fault

### Warm Resets

The MIC3002 can be reset to its power-on default state during operation by setting the reset bit in OEMCFG0. When this bit is set, TXFAULT and RXLOS will be deasserted, all registers will be restored to their normal power-on default values, and any A/D conversion in progress will be halted and the results discarded. The state of the MIC3002 following this operation is indistinguishable from a power-on reset.

### Power-On Hour Meter

The Power-On Hour meter logs operating hours using an internal real-time clock and stores the result in NVRAM. The hour count is incremented at ten-hour intervals in the middle of each interval. The first increment therefore takes place five hours after power-on. Time is accumulated whenever the MIC3002 is powered. The hour meter's time base is accurate to 5% over all MIC3002 operating conditions. The counter is capable of storing counts of more than thirty years, but is ultimately limited by the write-cycle endurance of the non-volatile

memory. This implies a range of at least twenty years. Actual results will depend upon the operating conditions and write-cycle endurance of the part in question.

Two registers, POHH and POHI, contain a 15-bit power-on hour measurement and an error flag, POHFLT. Great care has been taken to make the MIC3002's hour meter immune to data corruption and to insure that valid data is maintained across power cycles. The hour meter employs multiple data copies and error correction codes to maintain data validity. This data is stored in the POHDATA registers. If POHFLT is set, however, the power-on hour meter data has been corrupted and should be ignored.

It is recommended that a two-byte (or more) sequential read operation be performed on POHH and POHI to insure coherency between the two registers. These registers are accessible by the OEM using a valid OEM password. The only operation that should be performed on these registers is to clear the hour meters initial value, if necessary, at the time of product shipment. The hour meter result may be cleared by setting all eight POHDATA bytes to 00<sub>h</sub>.

Power-On Hour Result Format		
High Byte, POHH		Low Byte, POHI
Error Flag	Elapsed Time / 10 Hours, MSBs	Elapsed Time / 10 Hours, LSBs
MSB		LSB

Table 23. Power-On Hour Meter Result Format

### Test and Calibration Features

Numerous features are included in the MIC3002 to facilitate development, testing, and diagnostics. These

features are available via registers in the OEM area. As shown in Table 24, these features include:

Function	Description	Control Register(s)
Analog loop-back	Provides analog visibility of op-amp and DAC outputs via the ADC	OEMCFG0
Fault comparator disable control	Disables the fault comparator	OEMCAL0
Fault comparator spin-on-channel mode	Selects a single fault comparator channel	OEMCAL0
Fault comparator output read-back	Allows host to read individual fault comparator outputs	OEMRD
RSOUT, /INT read-back	Allows host to read the state of these pins	OEMRD
Inhibit EEPROM write cycles	Speeds repetitive writes to registers backed up by NVRAM	OEMCAL0
APC calibration mode	Allows direct writes to MODDAC and APCDAC (temperature compensation not used)	OEMCAL0
Continuity checking	Forcing of RXLOS, TXFAULT, /INT	OEMCAL0
Halt A/D	Stops A/D conversions; ADC in one-shot mode	OEMCAL1
ADC idle flag	Indicates ADC status	OEMCAL1
A/D one-shot mode	Performs a single A/D conversion on the selected input channel	OEMCAL1
A/D spin-on-channel mode	Selects a single input channel	OEMCAL1
Channel selection	Selects ADC or fault comparator channel for spin-on-channel modes	OEMCAL1
LUT index read-back	Permits visibility of the LUT index calculated by the state-machine	LUTINDX
Manufacturer and device ID registers	Facilitates presence detection and version control	MFG_ID, DEV_ID

**Table 24. Test and Diagnostic Features**

## Serial Port Operation

The MIC3002 uses standard Write\_Byte, Read\_Byte, and Read\_Word operations for communication with its host. It also supports Page\_Write and Sequential\_Read transactions. The Write\_Byte operation involves sending the device's slave address (with the R/W bit low to signal a write operation), followed by the address of the register to be operated upon and the data byte. The Read\_Byte operation is a composite write and read operation: the host first sends the device's slave address followed by the register address, as in a write operation. A new start bit must then be sent to the MIC3002, followed by a repeat of the slave address with the R/W bit (LSB) set to the high (read) state. The data to be read from the part may then be clocked out. A Read\_Word is similar, but two successive data bytes are clocked out rather than one. These protocols are shown in Figures 21 to 24.

The MIC3002 will respond to up to four sequential slave addresses depending upon whether it is in OEM or User mode. A match between one of the MIC3002's addresses and the address specified in the serial bit stream must be made to initiate communication. The MIC3002 responds to slave addresses A0<sub>h</sub> and A2<sub>h</sub> in User Mode; it also responds to A4<sub>h</sub> and A6<sub>h</sub> in OEM Mode (assuming I2CADDR = Ax<sub>h</sub>).

## Page Writes

To increase the speed of multi-byte writes, the MIC3002 allows up to four consecutive bytes (one page) to be written before the internal write cycle begins. The entire non-volatile memory array is organized into four-byte pages. Each page begins on a register address boundary where the last two bits of the address are 00<sub>b</sub>. Thus, the page is composed of any four consecutive bytes having the addresses xxxxxx00<sub>b</sub>, xxxxxx01<sub>b</sub>, xxxxxx10<sub>b</sub>, and xxxxxx11<sub>b</sub>.

The page write sequence begins just like a Write\_Byte operation with the host sending the slave address, R/W bit low, register address, etc. After the first byte is sent the host should receive an acknowledge. Up to three more bytes can be sent in sequence. The MIC3002 will acknowledge each one and increment its internal address register in anticipation of the next byte. After the last byte is sent, the host issues a STOP. The MIC3002's internal write process then begins. If more than four bytes are sent, the MIC3002's internal address counter wraps around to the beginning of the four-byte page.

To accelerate calibration and testing, NVRAM write cycles can be disabled completely by setting the WRINH bit in OEMCAL0. Writes to registers that do not have NVRAM backup, will not incur write-cycle delays when writes are inhibited. Write operations on registers that exist only in NVRAM will still incur write cycle delays.

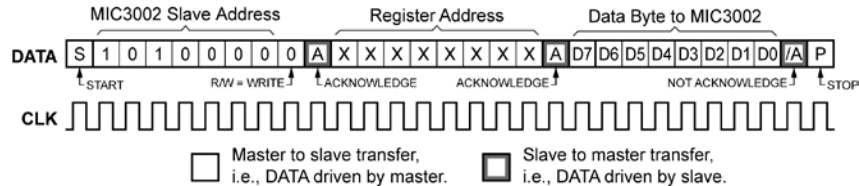


Figure 21. Write Byte Protocol

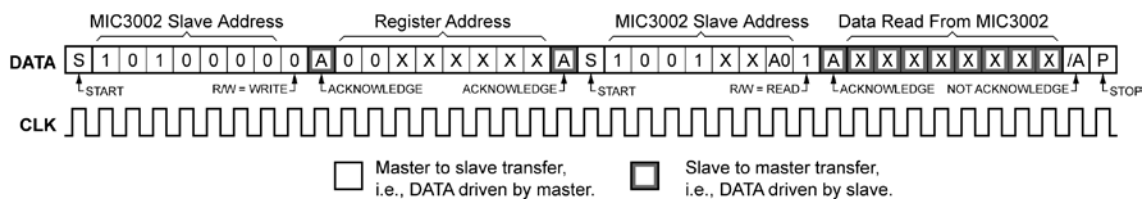


Figure 22. Read Byte Protocol

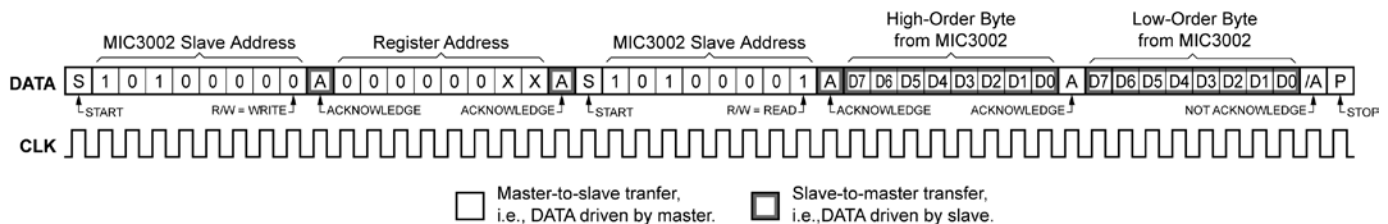


Figure 23. Read\_Word Protocol

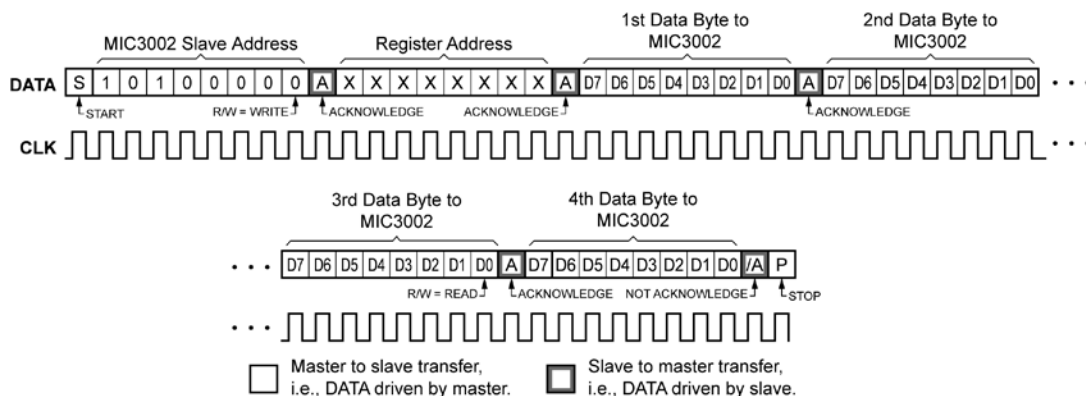


Figure 24. Four-Byte Page Write Protocol

### Acknowledge Polling

The MIC3002's non-volatile memory cannot be accessed during the internal write process. To allow for maximum speed bulk writes, the MIC3002 supports acknowledge polling. The MIC3002 will not acknowledge serial bus transactions while internal writes are in progress. The host may therefore monitor for the end of the write process by periodically checking for an acknowledgement.

### Write Protection and Data Security

#### OEM Password

A password is required to access the OEM areas of the MIC3002, specifically the non-volatile memory, look-up tables, and registers at serial addresses  $A4_h$  and  $A6_h$ . A four-byte field, OEMPWSET, at serial address  $A6_h$  is used for setting the OEM password. The OEM password is set by writing OEMPWSET with the new value. The password comparison is performed following the write to the MSB of the OEMPW, address  $7B_h$  (or  $7E_h$ ) at serial address  $A2_h$ . Therefore, this byte must be written last. A four-byte burst-write sequence to address  $78_h$  (or  $7B_h$ ) may be used as this will result in the MSB being written last. The new password will not take effect until after a power-on reset occurs or a warm reset is performed using the RST bit in OEMCFG0. This allows the new password to be verified before it takes effect.

The corresponding four-byte field for password entry, OEMPW, is located at serial address  $A2_h$ . This field is therefore always visible to the host system. OEMPW is compared to the four-byte OEMPWSET field at serial address  $A6_h$ . If the two fields match, access is allowed to the OEM areas of the MIC3002 non-volatile memory at serial addresses  $A4_h$  and  $A6_h$ . If OEMPWSET is all zeroes, no password security will exist. The value in OEMPW will be ignored. This helps prevent a deliberately unsecured MIC3002 from being inadvertently locked. Once a valid

password is entered, the MIC3002 OEM areas will be accessible. The OEM areas may be re-secured by writing an incorrect password value at OEMPW, e.g., all zeroes. In all cases, OEMPW must be written LSB first through MSB last. The OEM areas will be inaccessible following the final write operation to OEMPW's LSB. The OEMPW field is reset to all zeros at power on. Any values written to these locations will be readable by the host regardless of the locked/unlocked status of the device. If OEMPWSET is set to zero ( $00000000_h$ ), the MIC3002 will remain unlocked regardless of the contents of the OEMPW field. This is the factory default security setting.

Note that a valid OEM password allows access to the OEM and user areas of the chip, i.e., the entire memory map, regardless of any user password that may be in place. Once the OEM areas are locked, the user password can provide access and write protection for the user areas.

#### User Password

A password is required to access the USER areas of the MIC3002, specifically, the non-volatile memory at serial addresses  $A0_h$  and  $A2_h$ . A one-byte field, USRPWSET at serial address  $A2_h$  is used for setting the USER password. USRPWSET is compared to the USRPW field at serial address  $A2_h$ . If the two fields match, access is allowed to the USER areas of the MIC3002 non-volatile memory at serial addresses  $A0_h$  and  $A2_h$ . The USER password is set by writing USRPWSET with the new value. The new password will not take effect until after a power-on reset occurs or a warm reset is performed using the RST bit in OEMCFG0. This allows the new password to be verified before it takes effect.

Note also that a valid OEM password allows access to the OEM and user areas of the chip, i.e., the entire memory map, regardless of any user password that may be in place. Once the OEM areas are locked, the user password can then provide access and write protection for the user areas. If a valid OEM password is in place, the user password will have no effect.

## Detailed Register Descriptions

Note: Serial bus addresses shown assume that I2CADR = A<sub>xh</sub>.

### Alarm Threshold Registers

Temperature High Alarm Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0°C)				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (TXMAHh): 00 = 00 <sub>h</sub> LSB (TXMAHl): 00 = 01 <sub>h</sub>				
Each LSB of TMAXh represents one degree centigrade. This register is to be used in conjunction with TMAXl to yield a sixteen-bit temperature value. The value in this register is uncalibrated. The nine MSbits of threshold value (TMAXh;TMAXl) are compared bit to bit to the nine MSbits value of the temperature reading (TEMPH;TEMPl).. Alarm bit Ax is set if Reading > Threshold.							

Temperature Low Alarm Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0°C)				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (TMINh): 02 = 02 <sub>h</sub>  LSB (TMINl): 02 = 02 <sub>h</sub>				
Each LSB of TMINh represents one degree centigrade. TMINh is to be used in conjunction with TMINl to yield a sixteen-bit temperature value. The value in this register is uncalibrated. The nine MSbits of threshold value (TMINh;TMINl) are compared, bit to bit, to The nine MSbits value of the temperature reading (TEMP <sub>h</sub> ;TEMP <sub>l</sub> ). Alarm bit Ax is set if Reading < Threshold.							

Voltage High Alarm Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0V)				
Serial Address			A2 <sub>h</sub>				
Bytes Address			MSB (VMAXh): 08 = 08 <sub>h</sub> LSB (VMAXl): 09 = 09 <sub>h</sub>				
Each LSB of VMAXh represents 25.6mV and each LSB of VMAXl represents 0.1mV. The sixteen bits threshold value (VMAXh;VMAXl) is compared bit to bit to the sixteen bits value of the voltage reading (VINh;VINl). Alarm bit Ax is set if Reading > Threshold.							



Voltage Low Alarm Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0V)				
Serial Address			A2 <sub>h</sub>				
Bytes Address			MSB (VMINh): 10 = 0A <sub>h</sub> LSB (VMINI): 11 = 0B <sub>h</sub>				
Each LSB of VMINh represents 25.6mV and each LSB of VMINI represents 0.1mV. The sixteen bits threshold value (VMINh;VMINI) is compared bit to bit to the sixteen bits value of the voltage reading (VINh;VINI). Alarm bit Ax is set if Reading < Threshold.							

Bias Current High Alarm Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mA)				
Serial Address			A2 <sub>h</sub>				
Bytes Address			MSB (IMAXh): 16 = 10 <sub>h</sub> LSB (IMAXI): 17 = 11 <sub>h</sub>				
Each LSB of IMAXh represents 512μA and each LSB of IMAXI represents 2μA. The sixteen bits threshold value (IMAXh;IMAXI) is compared, bit to bit, to the sixteen bits value of the bias current reading (ILDh:ILDI). Alarm bit Ax is set if Reading > Threshold.							

Bias Current Low Alarm Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mA)				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (IMINh): 18 = 12 <sub>h</sub> LSB (IMINI): 19 = 13 <sub>h</sub>				
Each LSB of IMINh represents 512μA and each LSB of IMINI represents 2μA. The sixteen bits threshold value (IMINh;IMINI) is compared, bit to bit, to the sixteen bits value of the bias current reading (ILDh:ILDI). Alarm bit Ax is set if Reading < Threshold.							

TX Optical Power High Alarm							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mW)				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (TXMAXh): 24 = 18 <sub>h</sub> LSB (TXMAXI): 25 = 19 <sub>h</sub> 24 = 18 <sub>h</sub>				
Each LSB of TXMAXh represents 25.6μW. This register is to be used in conjunction with TXMAXI to yield a sixteen-bit value. The values in TXMAXh:TXMAXI are in an unsigned binary format. The value in this register is uncalibrated. The sixteen bits threshold value (TXMAXh;TXMAXI) is compared, bit to bit, to the sixteen bits value of the TX power reading (TXOPh:TXOPI). Alarm bit Ax is set if Reading > Threshold.							

TX Optical Power Low Alarm							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mW)				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (TXMAXh): 24 = 18 <sub>h</sub> LSB (TXMAXl): 25 = 19 <sub>h</sub>				
Each LSB of TXMINh represents 25.6μW. This register is to be used in conjunction with TXMINl to yield a sixteen-bit value. The values in TXMINh:TMINI are in an unsigned binary format. The value in this register is uncalibrated. The sixteen bits threshold value (TXMINh;TXMINl) is compared, bit to bit, to the sixteen bits value of the RTX power reading (TXOPh:TXOPl). Alarm bit Ax is set if Reading < Threshold.							

RX Optical Power High Alarm Threshold MSB (RXMAXh)							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mW)				
Serial Address			A2 <sub>h</sub>				
Bytes Address			MSB (RXMAXh): 32 = 20 <sub>h</sub> LSB (RXMAXl): 33 = 21 <sub>h</sub>				
Each LSB of RXMAXh represents 25.6μW. This register is to be used in conjunction with RXMAXl to yield a sixteen-bit value. The value in this register is uncalibrated. The sixteen bits threshold value (RXMAXh;RXMAXl) is compared, bit to bit, to the sixteen bits value of the RX power reading (RXOPh:RXOPl). Alarm bit Ax is set if Reading > Threshold.							

RX Optical Power Low Alarm Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mW)				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (RXMINh): 34 = 22 <sub>h</sub> LSB (RXMINl): 35 = 23 <sub>h</sub>				
Each LSB of RXMINh represents 25.6μW. This register is to be used in conjunction with RXMINl to yield a sixteen-bit value. The value in this register is uncalibrated. The sixteen bits threshold value (RXMINh:RXMINl) is compared, bit to bit, to the sixteen bits value of the RX power reading (RXOPh:RXOPl). Alarm bit Ax is set if Reading < Threshold.							

## Warning Threshold Registers

Temperature High Warning Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0°C)				
Serial Address			A2 <sub>h</sub>				
Bytes Address			MSB (THIGHh): 04 = 04 <sub>h</sub> LSB (THIGHl): 05 = 05 <sub>h</sub>				
Each LSB of THIGHh represents one degree centigrade. This register is to be used in conjunction with THIGHl to yield a sixteen-bit temperature value. The value in this register is uncalibrated. The nine MSbits of threshold value (THIGHh;THIGHl) are compared, bit to bit, to the nine MSbits value of the temperature reading (TEMPH;TEMPI).. Warning bit Wx is set if Reading > Threshold.							

Temperature Low Warning Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0°C)				
Serial Address			A2 <sub>h</sub>				
Bytes Address			MSB (TLOWh): 06 = 06 <sub>h</sub> LSB (TLOWl): 06 = 06 <sub>h</sub>				
Each LSB of TLOWh represents one degree centigrade. This register is to be used in conjunction with TLOWl to yield a sixteen-bit temperature value. The value in this register is uncalibrated. The threshold value (THIGHh;THIGHl) is compared, bit to bit, to the value of the temperature reading (TEMPH;TEMPI). Warning bit Wx is set if Reading < Threshold.							

Voltage High Warning Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0V)				
Serial Address			A2 <sub>h</sub>				
Bytes Address			MSB (VHIGHh): 12 = 0C <sub>h</sub> LSB (VHIGHl): 13 = 0D <sub>h</sub> 12 = 0C <sub>h</sub>				
Each LSB of VHIGHh represents 25.6mV. This register is to be used in conjunction with VHIGHl to yield a sixteen-bit value. The value in this register is uncalibrated. The threshold value (VHIGHh;VHIGHl) is compared. bit to bit. to the value of the voltage reading (VINh;VINl). Warning bit Wx is set if Reading > Threshold.							

Voltage Low Warning Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0V)				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (VLOW <sub>h</sub> ): 14 = 0E <sub>h</sub> LSB (VLOW <sub>l</sub> ): 15 = 0F <sub>h</sub>				
Each LSB of VLOW <sub>h</sub> represents 25.6mV. This register is to be used in conjunction with VLOW <sub>l</sub> to yield a sixteen-bit value. The value in this register is uncalibrated. The threshold value (VLOW <sub>h</sub> ;VLOW <sub>l</sub> ) is compared. bit to bit, to the value of the voltage reading (VIN <sub>h</sub> ;VIN <sub>l</sub> ). Warning bit W <sub>x</sub> is set if Reading < Threshold.							

Bias Current High Warning Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mA)				
Serial Address			A2 <sub>h</sub>				
Bytes Address			MSB (IHIGHh): 20 = 14 <sub>h</sub> LSB (IHIGHl): 21 = 15 <sub>h</sub>				
Each LSB of IHIGHh represents 512μA and each LSB of IHIGHl represents 2μA. The sixteen bits threshold value (IHIGHh;IHIGHl) is compared, bit to bit, to the sixteen bits value of the bias current reading (ILDh:ILDl). Warning bit Wx is set if Reading > Threshold.							

Bias Current Low Warning Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mA)				
Serial Address			A2 <sub>h</sub>				
Bytes Address			MSB (ILOWh): 22 = 16 <sub>h</sub> LSB (ILOWl): 23 = 17 <sub>h</sub>				
Each LSB of ILOWh represents 512μA and each LSB of ILOWl represents 2μA. The sixteen bits threshold value (ILOWh;ILOWl) is compared, bit to bit, to the sixteen bits value of the bias current reading (ILDh:ILDl). Warning bit Wx is set if Reading < Threshold.							

TX Optical Power High Warning MSB (TXHIGHh)							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mW)				
Serial Address			A2 <sub>h</sub>				
Bytes Address			MSB (TXHIGHh): 28 = 1C <sub>h</sub> LSB (TXHIGHl): 29 = 1D <sub>h</sub>				
Each LSB of TXHIGHh represents 25.6μW. This register is to be used in conjunction with TXHIGHl to yield a sixteen-bit value. The values in TXHIGHh:TXHIGHl are in an unsigned binary format. The value in this register is uncalibrated. The sixteen bits threshold value (TXHIGHh;TXHIGHl) is compared, bit to bit, to the sixteen bits value of the TX power reading (TXOPh:TXOPl). Warning bit Wx is set if Reading > Threshold.							

TX Optical Power Low Warning							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mW)				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (TXLOW <sub>h</sub> ): 30 = 1E <sub>h</sub> LSB (TXLOW <sub>l</sub> ): 31 = 1F <sub>h</sub>				
Each LSB of TXLOW <sub>h</sub> represents 25.6μW. This register is to be used in conjunction with TXLOW <sub>l</sub> to yield a sixteen-bit value. The values in TXLOW <sub>h</sub> :TLOW <sub>l</sub> are in an unsigned binary format. The value in this register is uncalibrated. The sixteen bits threshold value (TXLOW <sub>h</sub> ;TXLOW <sub>l</sub> ) is compared, bit to bit, to the sixteen bits value of the TX power reading (TXOP <sub>h</sub> :TXOP <sub>l</sub> ). Warning bit W <sub>x</sub> is set if Reading < Threshold.							

RX Optical Power High Warning Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mW)				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (RXHIGHh): 36 = 24 <sub>h</sub> LSB (RXHIGHl): 37 = 25 <sub>h</sub>				
Each LSB of RXHIGHh represents 25.6μW and each ach LSB of RXHIGHl represents 0.1μW.. The value in this register is uncalibrated. The sixteen bits threshold value (RXHIGHh;RXHIGHl) is compared, bit to bit, to the sixteen bits value of the RX power reading (RXOPh:RXOPl). Warning bit Wx is set if Reading > Threshold.							

RX Optical Power Low Warning Threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mW)				
Serial Address			A2 <sub>h</sub>				
Byte Address			38 = 26 <sub>h</sub>				
Each LSB of RXLOW <sub>h</sub> represents 25.6μW and each eah LSB of RXLOW <sub>l</sub> represents 0.1μW. The value in this register is uncalibrated. The sixteen bits threshold value (RXLOW <sub>h</sub> ;RXLOW <sub>l</sub> ) is compared, bit to bit, to the sixteen bits value of the RX power reading (RXOP <sub>h</sub> :RXOP <sub>l</sub> ). Warning bit W <sub>x</sub> is set if Reading > Threshold.							

Checksum (CHKSUM) Checksum of bytes 0 - 94 at serial address A2h							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0°C)				
Serial Address			A2 <sub>h</sub>				
Byte Address			95 = 5F <sub>h</sub>				
This register is provided for compliance with SFF-8472. It is implemented as general-purpose non-volatile memory. Read/write access is possible whenever a valid OEM password has been entered. CHKSUM is read-only in USER mode.							

## ADC Result Registers

Temperature Result							
D[7] read-only	D[6] read-only	D[5] read-only	D[4] read-only	D[3] read-only	D[2] read-only	D[1] read-only	D[0] read-only
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0°C) <sup>(1)</sup>				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (TEMP <sub>h</sub> ): 96 = 60 <sub>h</sub> LSB (TEMP <sub>l</sub> ): 97 = 61 <sub>h</sub>				
Each LSB of TEMP <sub>h</sub> represents one degree centigrade. The TEMP <sub>h</sub> register is to be used in conjunction with TEMP <sub>l</sub> to yield a sixteen-bit temperature value. If OEMCFG6 bit 1 is a zero, temperature is read to 1°C resolution in TEMP <sub>h</sub> only, and TEMP <sub>l</sub> is zero. If OEMCFG6 bit 1 is a one, then temperature is read to 0.5°C resolution as a nine-bit value consisting of TEMP <sub>h</sub> and the MS bit of TEMP <sub>l</sub> . The lower seven bits of TEMP <sub>l</sub> are zero.							

Voltage							
D[7] read-only	D[6] read-only	D[5] read-only	D[4] read-only	D[3] read-only	D[2] read-only	D[1] read-only	D[0] read-only
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0V) <sup>(2)</sup>				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (VIN <sub>h</sub> ): 98 = 62 <sub>h</sub> LSB (VIN <sub>l</sub> ): 99 = 63 <sub>h</sub>				
Each LSB of VIN <sub>h</sub> represents 25.6mV. VIN <sub>h</sub> register is to be used in conjunction with VIN <sub>l</sub> to yield a sixteen-bit value. The values in VIN <sub>h</sub> :VIN <sub>l</sub> are in an unsigned binary format. The value in this register is uncalibrated. The host should process the results using the scale factor and offset provided. See the External Calibration section. In the MIC3002, VIN <sub>l</sub> will always return zero. It is provided for compliance with SFF-8472.							

**Notes:**

1. TEMP<sub>h</sub> will contain measured temperature data after the completion of one conversion.
2. VIN<sub>h</sub> will contain measured data after one A/D conversion cycle.

Laser Diode Bias Current							
D[7] read-only	D[6] read-only	D[5] read-only	D[4] read-only	D[3] read-only	D[2] read-only	D[1] read-only	D[0] read-only
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mA) <sup>(3)</sup>				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (ILD <sub>h</sub> ):100 = 64 <sub>h</sub> LSB (ILD <sub>I</sub> ):100 = 65 <sub>h</sub>				
ILD <sub>h</sub> is to be used in conjunction with ILD <sub>I</sub> to yield a sixteen-bit value. The values in ILD <sub>h</sub> :ILD <sub>I</sub> are in an unsigned binary format. The value in this register is uncalibrated. The host should process the results using the scale factor and offset provided. See the External Calibration sections. In the MIC3002, ILD <sub>I</sub> will always return zero. It is provided for compliance with SFF-8472.							

Transmitted Optical Power							
D[7] read-only	D[6] read-only	D[5] read-only	D[4] read-only	D[3] read-only	D[2] read-only	D[1] read-only	D[0] read-only
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mW) <sup>(5)</sup>				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (TXOP <sub>h</sub> ): 102 = 66 <sub>h</sub> LSB (TXOP <sub>I</sub> ): 103 = 67 <sub>h</sub>				
Each LSB of TXOP <sub>h</sub> represents 25.6μW. THOP <sub>h</sub> is to be used in conjunction with TXOP <sub>I</sub> to yield a sixteen-bit value. The values in TXOP <sub>h</sub> :TXOP <sub>I</sub> are in an unsigned binary format. The value in this register is uncalibrated. The host should process the results using the scale factor and offset provided. See the External Calibration section. In the MIC3002, this TXOP <sub>I</sub> will always return zero. It is provided for compliance with SFF-8472.							

**Notes:**

3. ILD<sub>h</sub> will contain measured data after one A/D conversion cycle.
4. The scale factor corresponding to the sense resistor used must be set in the configuration register.
5. TXOP<sub>h</sub> will contain measured data after one A/D conversion cycle.

Received Optical Power							
D[7] read-only	D[6] read-only	D[5] read-only	D[4] read-only	D[3] read-only	D[2] read-only	D[1] read-only	D[0] read-only
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (0mW) <sup>(6)</sup>				
Serial Address			A2 <sub>h</sub>				
Byte Address			MSB (RXOPh): 104 = 68 <sub>h</sub> LSB (RXOPI): 105 = 69 <sub>h</sub>				
Each LSB of RXOPI represents 25.6μW and each LSB of RXOPh represents 0.1μW. RXOPh is to be used in conjunction with RXOPI to yield a sixteen-bit value. The values in RXOPh:RXOPI are in an unsigned binary format. The value in this register is uncalibrated. The host should process the results using the scale factor and offset provided. See the External Calibration section.							

Control and Status (CNTRL)							
D[7] TXDIS read-only	D[6] STXDIS read/write	D[5] reserved	D[4] RSEL read/write	D[3] SRSEL read/write	D[2] XFLT read-only	D[1] LOS read-only	D[0] POR read-only
Default Value					0000 0000 <sub>b</sub> = 00 <sub>h</sub>		
Serial Address					A2 <sub>h</sub>		
Byte Address					110 = 6E <sub>h</sub>		

Bit(s)		Function	Operation
D[7]	TXDIS	Reflects the state of the TXDISABLE pin	1 = disabled, 0 = enabled, read only.
D[6]	STXDIS	Soft transmit disable	1 = disabled; 0 = enabled.
D[5]	D[5]	Reserved	Reserved - always write as zero.
D[4]	RSEL	Reflects the state of the RSEL pin	1 = high; 0 = low.
D[3]	SREL	Soft rate select	1 = high (2Gbps); 0 = low (1Gbps).
D[2]	TXFLT	Reflects the state of the TXFAULT pin	1 = high (fault); 0 = low (no fault).
D[1]	LOS	Loss of signal. Reflects the state of the LOS pin	1 = high (loss of signal); 0 = low (no loss of signal).
D[0]	POR	MIC3002 power-on status	0 = POR complete, analog data ready; 1 = POR in progress.

**Notes:**

6. RXOPh will contain measured data after one A/D conversion cycle.



## Alarm Flags

Alarm Status Register 0 (ALARM0)							
D[7] A7 read-only	D[6] A6 read-only	D[5] A5 read-only	D[4] A4 read-only	D[3] A3 read-only	D[2] A2 read-only	D[1] A1 read-only	D[0] A1 read-only
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (no events pending)				
Serial Address			A2 <sub>h</sub>				
Byte Address			112 = 70 <sub>h</sub>				
The power-up default value is 00 <sub>h</sub> . Following the first A/D conversion, however, any of the bits may be set depending upon the results.							

Bit(s)		Function	Operation
D[7]	A7	High temperature alarm, TEMP > TMAX <sub>h</sub>	1 = condition exists, 0 = normal/OK.
D[6]	A6	Low temperature alarm, TEMP <sub>h</sub> < TMIN	1 = condition exists, 0 = normal/OK.
D[5]	A5	High voltage alarm, VIN > VMAX	1 = condition exists, 0 = normal/OK.
D[4]	A4	Low voltage alarm, VIN < VMIN	1 = condition exists, 0 = normal/OK.
D[3]	A3	High laser diode bias alarm, IBIAS > IMAX	1 = condition exists, 0 = normal/OK.
D[2]	A2	Low laser diode bias alarm, IBIAS < IMIN	1 = condition exists, 0 = normal/OK.
D[1]	A1	High transmit optical power alarm, TXOP > TXMAX	1 = condition exists, 0 = normal/OK.
D[0]	A0	Low transmit optical power alarm, TXOP < TXMIN	1 = condition exists, 0 = normal/OK.

Alarm Status Register 1 (ALARM1)							
D[7] A15 read-only	D[6] A14 read-only	D[5] reserved	D[4] reserved	D[3] reserved	D[2] reserved	D[1] reserved	D[0] reserved
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (no events pending)				
Serial Address			A2 <sub>h</sub>				
Byte Address			113 = 71 <sub>h</sub>				
The power-up default value is 00 <sub>h</sub> . Following the first A/D conversion, however, any of the bits may be set depending upon the results.							

Bit(s)		Function	Operation
D[7]	A15	High received power (overload) alarm, RXOP > RXMAX	1 = condition exists, 0 = normal/OK.
D[6]	A14	Low received power (LOS) alarm, RXOP < RXMIN	1 = condition exists, 0 = normal/OK.
D[5:0]		Reserved	Reserved - always write as zero.

## Warning Flags

Warning Status Register 0 (WARN0)							
D[7] W7 read-only	D[6] W6 read-only	D[5] W5 read-only	D[4] W4 read-only	D[3] W3 read-only	D[2] W2 read-only	D[1] W1 read-only	D[0] W1 read-only
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (no events pending)				
Serial Address			A2 <sub>h</sub>				
Byte Address			116 = 74 <sub>h</sub>				
The power-up default value is 00 <sub>h</sub> . Following the first A/D conversion, however, any of the bits may be set depending upon the results.							

Bit(s)		Function	Operation
D[7]	W7	High temperature warning, TEMP > THIGH	1 = condition exists, 0 = normal/OK.
D[6]	W6	Low temperature warning, TEMP < TLOW	1 = condition exists, 0 = normal/OK.
D[5]	W5	High voltage warning, VIN > VHIGH	1 = condition exists, 0 = normal/OK.
D[4]	W4	Low voltage warning, VIN < VLOW	1 = condition exists, 0 = normal/OK.
D[3]	W3	High laser diode bias warning, IBIAS > IHIGH	1 = condition exists, 0 = normal/OK.
D[2]	W2	Low laser diode bias warning, IBIAS < ILOW	1 = condition exists, 0 = normal/OK.
D[1]	W1	High transmit optical power warning, TXOP > TXHIGH	1 = condition exists, 0 = normal/OK.
D[0]	W0	Low transmit optical power warning, TXOP < TXLOW	1 = condition exists, 0 = normal/OK.

Warning Status Register 1 (WARN1)							
D[7] W15 read-only	D[6] W14 read-only	D[5]  read-only	D[4]  read-only	D[3]  read-only	D[2]  read-only	D[1]  read-only	D[0]  read-only
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (no events pending)				
Serial Address			A2 <sub>h</sub>				
Byte Address			117 = 75 <sub>h</sub>				
The power-up default value is 00 <sub>h</sub> . Following the first A/D conversion, however, any of the bits may be set depending upon the results.							

Bit(s)		Function	Operation
D[7]	W15	Received power high warning, RXOP > RXHIGH	1 = condition exists, 0 = normal/OK.
D[6]	W14	Received power low warning, RXOP < RXMIN	1 = condition exists, 0 = normal/OK.
D[5:0]		Reserved	Reserved - always write as zero.

OEM Password Entry (OEMPW)							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub> (reset to zero at power-on)				
Serial Address			A2 <sub>h</sub>				
Byte Address			If OEMCFG5-2 = 0: 120 – 123 = 78 <sub>h</sub> - 7B <sub>h</sub> (MSB is 7B <sub>h</sub> If OEMCFG5-2 = 1: 123– 126 = 7B <sub>h</sub> - 7E <sub>h</sub> (MSB is 7E <sub>h</sub> )				
<p>This four-byte field is for entry of the password required to access the OEM area of the MIC3002's memory and registers. A valid OEM password will also permit access to the user areas of memory. The byte at address 123 (7B<sub>h</sub>), 126 (7E<sub>h</sub>) if OMGFG5 bit2 =1, is the most significant byte. This field is compared to the four-byte OEMPWSET field at serial address A6<sub>h</sub>, bytes 12 to 15. If the two fields match, access is allowed to the OEM areas of the MIC3002 non-volatile memory at serial addresses A4<sub>h</sub> and A6<sub>h</sub>. The OEM password is set by writing the new value into OEMPWSET. The password comparison is performed following the write to the MSB, address 7B<sub>h</sub> (7E<sub>h</sub> if OEMCFG5-2 = 1). This byte must be written last!</p> <p>A four-byte burst-write sequence to address 78<sub>h</sub>(7B<sub>h</sub> if OEMCFG5-2 = 1) may be used as this will result in the MSB being written last. The new password will not take effect until after a power-on reset occurs or a warm reset is performed using the RST bit in OEMCFG0. This allows the new password to be verified before it takes effect. This field is reset to all zeros at power on. Any values written to these locations will be readable by the host regardless of the locked/unlocked status of the device. If OEMPWSET is set to zero (00000000<sub>h</sub>), the MIC3002 will remain unlocked regardless of the contents of the OEMPW field.</p> <p>This is the factory default security setting.</p>							

Byte	Weight
3	OEM Password Entry, Most Significant Byte (Address = 7Bh resp. 7Eh)
2	OEM Password Entry, 2nd Most Significant Byte (Address = 7Ah resp. 7Dh)
1	OEM Password Entry, 2nd Least Significant Byte (Address = 79h resp. 7Ch)
0	OEM Password Entry, Least Significant Byte (Address = 78h resp. 7Bh)

USER Password Setting (USRPWSET)							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A2 <sub>h</sub>				
Byte Address			246 = F6 <sub>h</sub>				
<p>This register is for setting the password required to access the USER area of the MIC3002's memory and registers. This field is compared to the USRPW field at serial address A2<sub>h</sub>, byte 247(F7h). If the two fields match, access is allowed to the USER areas of the MIC3002 non-volatile memory at serial addresses A0h and A2h. If a valid USER password has not been entered, writes to the serial ID fields, USRCTRL, and the user scratchpad areas of A0<sub>h</sub> and A2<sub>h</sub> will not be allowed, and USRPWSET will be unreadable (returns all zeroes).</p> <p>A USER password is set by writing the new value into USRPWSET. The new password will not take effect until after a power-on reset occurs or a warm reset is performed using the RST bit in OEMCFG0. This allows the new password to be verified before it takes effect. This register is non-volatile and will be maintained through power and reset cycles. A valid USER or OEM password is required for access to this register. Otherwise, this register will read as 00<sub>h</sub>. Note: a valid OEM password overrides the USER password setting. If a valid OEM password is currently in place, the user password will have no effect.</p>							

USER Password (USRPW)							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A2 <sub>h</sub>				
Byte Address			247 = F7 <sub>h</sub>				
USER passwords are entered in this field. This field is compared to the USRPWSET field at serial address A2h, byte 246 (F6h). If the two fields match, access is allowed to the USER areas of the MIC3002 non-volatile memory at serial addresses A0h and A2h. If a valid USER password has not been entered, writes to the serial ID fields and user scratchpad areas of A0h and A2h will not be allowed and USRPWSET will be unreadable (returns all zeroes).							

Power-On Hours							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Bytes Address			MSB (POHh): 251 = FB <sub>h</sub> LSB (POHl): 252 = FC <sub>h</sub>				
The lower seven bits of POHh register contain the most-significant bits of the 15-bit power-on hours measurement. POHFLT is an error flag. The value in POHh should be combined with the Power-on Hours, Low Byte, POHl, to yield the complete result. If POHFLT is set, the power-on hour meter data has been corrupted and should be ignored. It is recommended that a two-byte (or more) sequential read operation be performed on POHh and POHl to insure coherency between the two registers. This register is non-volatile and will be maintained through power and reset cycle.							

POHh Bit(s)	Function	Operation
D[7]	Power-on hours fault flag	1 = fault; 0 = no fault.
D[6:0]	Power-on hours, high byte	Non-volatile.

Data Ready Flags (DATARDY)							
D[7] TRDY read/write	D[6] VRDY read/write	D[5] IRDY read/write	D[4] TXRDY read/write	D[3] RXDY read/write	D[2] reserved	D[1] reserved	D[0] reserved
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			253 = FD <sub>h</sub>				
When the A/D conversion for a given parameter is completed and the results available to the host, the corresponding data ready flag will be set. The flag will be cleared when the host reads the corresponding result register.							

Bit(s)		Function	Operation
D[7]	TRDY	Temperature data ready flag	0 = old data; 1 = new data ready
D[6]	VRDY	Voltage data ready flag	0 = old data; 1 = new data ready
D[5]	IRDY	Bias current data ready flag	0 = old data; 1 = new data ready
D[4]	TXRDY	Transmit power data ready flag	0 = old data; 1 = new data ready
D[3]	RXRDY	Receive power data ready flag	0 = old data; 1 = new data ready
D[2:0]		Reserved	Reserved

USER Control Register (USRCTL)							
D[7] read/write	D[6] PORM read/write	D[5] PORS read/write	D[4] IE read/write	D[3] APCSEL[1] read/write	D[2] APCSEL[0] read/write	D[1] MODSEL[1] read/write	D[0] MODSEL[0] read/write
Default Value			0010 0000 <sub>b</sub> = 20 <sub>h</sub>				
Serial Address			A2 <sub>h</sub>				
Byte Address			255 = FF <sub>h</sub> if OMCFG6 bit 2 = 0 222 = DE <sub>h</sub> if OMCFG6 bit 2 = 1				
<p>This register provides for control of the nominal APC setpoint and management of interrupts by the end-user. APCSEL[1:0] select which of the APC setpoint registers, APCSET0, APCSET1, or APCSET2 are used as the nominal automatic power control setpoint.</p> <p>IE must be set for any interrupts to occur. If PORM is set, the power-on event will generate an interrupt and warm resets using RST will not generate a POR interrupt. When a power-on interrupt occurs, assuming PORM=1, PORS will be set. PORS will be cleared and the interrupt output de-asserted when USRCTL is read by the host. If IE is set while /INT is asserted, /INT will be de-asserted. The host must still clear the various status flags by reading them. If PORM is set following the setting of PORS, PORS will remain set, and /INT will not be de-asserted, until USRCTL is read by the host.</p> <p>PORM, IE, and APCSEL are non-volatile and will be maintained through power and reset cycles. A valid USER password is required for access to this register.</p>							

Bit	Function	Operation
D[7]	Reserved	Always write as zero; reads undefined.
D[6]	PORM	Power-on interrupt mask 1 = POR interrupts enabled; 0 = disabled; read/write; non-volatile.
D[5]	PORS	Power-on interrupt flag 1 = POR interrupt occurred; 0 = no POR interrupt; read-only.
D[4]	IE	Global interrupt enable 1 = enabled; 0 = disabled; read/write; non-volatile.
D[3:2]	APCSEL	Selects APC setpoint register 00 = APCSET0, 01 = APCSET1, 10 = APCSET2; 11 = reserved; read/write; non-volatile.
D[1:0]	MODSEL	Selects Modulation setpoint register 00 = MODSET0, 01 = MODSET1, 10 = MODSET2, 11 = reserved; read/write; non volatile.

OEM Configuration Register 0 (OEMCFG0)							
D[7] RST write only	D[6] ZONE read/write	D[5] DFLT read only	D[4] OE reserved	D[3] MODREF reserved	D[2] VAUX[2] read/write	D[1] VAUX[1] read/write	D[0] VAUX[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			00 = 00 <sub>h</sub>				
A write to OEMCFG0 will result in any A/D conversion in progress being aborted and the result discarded. The A/D will begin a new conversion sequence once the write operation is complete. All bits in OEMCFG0 are non-volatile except DFLT and RST. A valid OEM password is required for access to this register.							

Bit(s)	Function	Operation
D[7]	RST	0 = no action; 1 = reset; write-only.
D[6]	ZONE	Selects temperature zone. 0 = internal; 1 = external; non-volatile.
D[5]	DFLT	Diode fault flag. 1 = diode fault; 0 = OK.
D[4]	OE	Output enable for SHDN, V <sub>MOD</sub> . 1 = enabled; 0 = hi-Z; non-volatile.

		and $V_{BIAS}$ .	
D[3]	MODREF	Selects whether $V_{MOD}$ is referenced to ground or $V_{DD}$ .	1 = $V_{DD}$ ; 0 = GND; non-volatile.
D[2:0]	VAUX[2:0]	Selects the voltage reported in $V_{INH}:V_{INI}$ .	000 = $V_{IN}$ ; 001 = $V_{DDA}$ ; 010 = $V_{BIAS}$ ; 011 = $V_{MOD}$ ; 100 = APCDAC; 101 = MODDAC; 110 = FLTDAC; non-volatile

**OEM Configuration Register 1 (OEMCFG1)**

D[7] INV read/write	D[6] GAIN read/write	D[5] BIASREF read/write	D[4] RFB[2] read/write	D[3] RFB[1] read/write	D[2] RFB[0] read/write	D[1] SRCE read/write	D[0] SPOL read/write
Default Value				0000 0000 <sub>b</sub> = 00 <sub>h</sub>			
Serial Address				A6 <sub>h</sub>			
Byte Address				1 = 01 <sub>h</sub>			

A write to OEMCFG1 will result in any A/D conversion in progress being aborted and the result discarded. The A/D will begin a new conversion sequence once the write operation is complete. All bits in OEMCFG1 are non-volatile and will be maintained through power and reset cycles. A valid OEM password is required for access to this register.

Bit(s)		Function	Operation
D[7]	INV	Inverts the APC op-amp inputs. When set to "0" the BIAS DAC output is connected to the "+" input and FB is connected to the "-" input of the op amp. Set to "0" to use the ADC feedback loop.	0 = emitter follower (no inversion); 1 = common emitter (inverted); read/write; non-volatile.
D[6]	GAIN	Sets the feedback voltage range by changing the APCDAC output swing; 0- $V_{REF}$ for optical feedback, 0- $V_{REF}/4$ for electrical feedback.	1 = $V_{REF}/4$ full scale; 0 = $V_{REF}$ full scale; read/write; non-volatile.
D[5]	BIASREF	Selects whether FB and VMPD are referenced to ground or $V_{DD}$ and selects feedback resistor termination voltage ( $V_{DDA}$ or GNDA).	1 = $V_{DD}$ ; 0 = GND; read/write; non-volatile.
D[4:2]	RFB[2:0]	Selects internal feedback resistance. (Resistors will be terminated to $V_{DDA}$ or GNDA according to BIASREF.)	000 = $\infty$ ; 001 = 800 $\Omega$ , 010 = 1.6k $\Omega$ , 011 = 3.2k $\Omega$ , 100 = 6.4k $\Omega$ , 101 = 12.8k $\Omega$ , 110 = 25.6k $\Omega$ , 111 = 51.2k $\Omega$ ; read/write; non-volatile.
D[1]	SRCE	$V_{BIAS}$ source vs. sink drive.	1 = source (NPN), 0 = sink (PNP); read/write; non-volatile.
D[0]	SPOL	Polarity of shutdown output, SHDN, when active.	1 = high; 0 = low; read/write; non-volatile.

OEM Configuration Register 2 (OEMCFG2)							
D[7] I2CADR[3] read/write	D[6] I2CADR[2] read/write	D[5] I2CADR[1] read/write	D[4] I2CADR[0] read/write	D[3]  read/write	D[2]  read/write	D[1]  read/write	D[0]  read/write
Default Value			1010 xxxx <sub>b</sub> = xx <sub>h</sub> (slave address = 1010xxx <sub>b</sub> )				
Serial Address			A6 <sub>h</sub>				
Byte Address			2 = 02 <sub>h</sub>				
CAUTION: Changes to I2CADR take effect immediately! Any accesses following a write to I2CADR must be to the newly programmed serial bus address. A valid OEM password is required for access to this register. This register is non-volatile and will be maintained through power and reset cycles.							

Bit(s)		Function	Operation
D[7:4]	I2CADR[3:0]	Upper four MSBs of the serial bus slave address; writes take effect immediately.	Read/write; non-volatile.
D[3:0]	Reserved		Read/write; non-volatile.

APC Setpoint x (APCSETx) Automatic power control setpoint (unsigned binary) used when APCSEL[1:0] = 00							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Bytes Address			APCSET0: 3 = 03 <sub>h</sub> APCSET1: 4 = 04 <sub>h</sub> APCSET2: 5 = 05 <sub>h</sub>				
When A.P.C. is on, i.e., the APCCAL bit in OEMCAL0 is set, the value in APCSETx is added to the signed value taken from the A.P.C. look-up table and loaded into the VBIAS DAC. When A.P.C. is off, the value in APCSET is loaded directly into the VBIAS DAC, bypassing the look-up table entirely. In either case, the VBIAS DAC setting is reported in the VBIAS register. The APCCFG bits determine the DAC's response to higher or lower numeric values. A valid OEM password is required for access to this register. This register is non-volatile and will be maintained through power and reset cycles.							

Modulation Setpoint x (MODSETx) Nominal V <sub>MOD</sub> setpoint							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			MODSET0: 6 = 06 <sub>h</sub> MODSET1: 30 = 1E <sub>h</sub> MODSET2: 31 = 1F <sub>h</sub>				
When A.P.C. is on, the value corresponding to the current temperature is taken from the MODLUT look-up table, added to MODSET and loaded into the V <sub>MOD</sub> DAC. This register is non-volatile and will be maintained through power and reset cycles. A valid OEM password is required for access to this register.							



I <sub>BIAS</sub> Fault Threshold (IBFLT) Bias current fault threshold							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			7 = 07 <sub>h</sub>				
A valid OEM password is required for access to this register. This register is non-volatile and will be maintained through power and reset cycles. A fault is generated if the bias current is higher than IBFLT value set in this register.							

Transmit Power Fault Threshold (TXFLT)							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			8 = 08 <sub>h</sub>				
A valid OEM password is required for access to this register. This register is non-volatile and will be maintained through power and reset cycles. A fault is generated if the Transmit power is higher than TXFLT value set in this register.							

Loss-Of-Signal Threshold (LOSFLT)							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			9 = 09 <sub>h</sub>				
A valid OEM password is required for access to this register. This register is non-volatile and will be maintained through power and reset cycles. A fault is generated if the received power is lower than LOSFLT value set in this register.							

Byte	Function	Operation
D[7:4]	Receive loss-of-signal threshold	Read/write; non-volatile.

Fault Suppression Timer (FLTMR) Fault suppression interval in increments of 0.5ms							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			10 = 0A <sub>h</sub>				
Saturation faults are suppressed for a time, t <sub>FLTMR</sub> , following laser turn-on. This avoids nuisance tripping while the APC loop starts up. The length of this interval is (FLTMRx 0.5ms), typical. A value of zero will result in no fault suppression. A valid OEM password is required for access to this register. This register is non-volatile and will be maintained through power and reset cycles.							

Fault Mask (FLTMSK)							
D[7] OEMIM read/write	D[6] POHE read/write	D[5] reserved	D[4] reserved	D[3] SATMSK read/write	D[2] TXMSK read/write	D[1] IAMSK read/write	D[0] DFMSK read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			11 = 0B <sub>h</sub>				
A valid OEM password is required for access to this register. This register is non-volatile and will be maintained through power and reset cycles.							

Bit	Function	Operation
D[7]	OEMIM	OEM interrupt mask bit 1 = masked; 0 = enabled; Read/write; non-volatile.
D[6]	POHE	OEM Power-on Hour Meter enable bit 1 = enabled; 0 = disabled; Read/write; non-volatile.
D[5:4]	D[5:4]	Reserved Always write as zero; reads undefined.
D[3]	SATMSK	APC saturation fault mask bit 1 = masked; 0 = enabled; Read/write; non-volatile.
D[2]	TXMSK	High TX optical power fault mask bit 1 = masked; 0 = enabled; Read/write; non-volatile.
D[1]	IAMSK	Bias current high alarm mask bit 1 = masked; 0 = enabled; Read/write; non-volatile.
D[0]	DFMSK	Diode fault mask bit 1 = masked; 0 = enabled; Read/write; non-volatile.

OEM Password Setting (OEMPWSET)							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			12 - 15 = 0C <sub>h</sub> - 0F <sub>h</sub> ; 0C <sub>h</sub> = MSB				
<p>This four-byte field is the password required for access to the OEM area of the MIC3002's memory and registers. The byte at address 12 (0C<sub>h</sub>) is the most significant byte. This field is compared to the four-byte OEMPW field at serial address A2<sub>h</sub>, byte 120 to 123 if OMCFG6-2 = 0, or byte 123 to 126 if OEMCFG6-2 = 1. If the two fields match, access is allowed to the OEM areas of the MIC3002 non-volatile memory at serial addresses A4<sub>h</sub> and A6<sub>h</sub>. The OEM password may be set by writing the new value into OEMPWSET. The new password will not take effect until after a power-on reset occurs or a warm reset is performed using the RST bit in OEMCFG0. This allows the new password to be verified before it takes effect. These registers are non-volatile and will be maintained through power and reset cycles. A valid OEM password is required for access to this register.</p>							

Byte	Weight
3	OEM Password, Most Significant Byte
2	OEM Password, 2nd Most Significant Byte
1	OEM Password, 2nd Least Significant Byte
0	OEM Password, Least Significant Byte

OEM Calibration 0 (OEMCAL0)							
D[7] reserved	D[6] FLTDIS read/write	D[5] FSPIN read/write	D[4] WRINH read/write	D[3] APCCAL read/write	D[2] FRCINT read/write	D[1] FRCTXF read/write	D[0] FRCLOS read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			16 = 10 <sub>h</sub>				
A valid OEM password is required for access to this register.							

Bit	Function	Operation
D[7]	Reserved	Always write as zero; reads undefined.
D[6]	FLTDIS	Fault comparator disable; inhibits output of fault comparators when set. 0 = faults enabled; 1 = disabled; Read/write.
D[5]	FSPIN	Fault comparator "spin-on-channel" mode select; do not enable ADC and FC spin-on-channel modes simultaneously. 0 = normal operation; 1 = spin on channel; Read/write.
D[4]	WRINH	Inhibit NVRAM write cycles. 0 = normal operation; 1 = inhibit writes; Read/write.
D[3]	APCCAL	Selects APC calibration mode - DACs may be controlled directly. 0 = normal mode; 1 = calibration mode; Read/write.
D[2]	FRCINT	Forces the assertion of /INT 0 = normal operation; 1 = asserted; Read/write.
D[1]	FRCTXF	Forces the assertion of TXFAULT 0 = normal operation; 1 = asserted; Read/write.
D[0]	FDCLOS	Forces the assertion of RXLOS 0 = normal operation; 1 = asserted; Read/write.

OEM Calibration 1 (OEMCAL1)							
D[7] reserved	D[6] ADSTP read/write	D[5] ADIDL read/write	D[4] 1SHOT read/write	D[3] ADSPIN read/write	D[2] SPIN[2] read/write	D[1] SPIN[1] read/write	D[0] SPIN[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			17 = 11 <sub>h</sub>				
A valid OEM password is required for access to this register.							

Bit	Function	Operation
D[7]	Reserved	Always write as zero; reads undefined.
D[6]	ADSTP	Stop ADC Halts the analog to digital converter 0 = normal operation; 1 = stopped; Read/write.
D[5]	ADIDL	ADC idle flag 0 = busy; 1 = idle; Read/write.
D[4]	1SHOT	Triggers one-shot A/D conversion cycle 0 = normal operation; 1 = one-shot; Read/write.
D[3]	ADSPIN	Selects ADC spin-on-channel mode; do not enable ADC and FC spin-on-channel modes simultaneously 0 = normal operation; 1 = spin-on-channel; Read/write.
D[2], D[1], D[0]	SPIN[2:0]	ADC and fault comparator (FC) channel select for spin-on-channel mode; do not enable ADC and FC spin-on-channel modes simultaneously ADC: 000 = temperature; 001 = voltage; 010 = VILD; 011 = VMPD; 100 = VRX; FC: 001 = VILD; 001 = VMPD; 010 = VRX; Read/write.

OEM Calibration 1 (LUT Index)							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			18 = 12h				
The look-up table index is derived from the current temperature measurement as follows:							
INDEX = TAVG / 2							
where T <sub>AVG</sub> (n) is the current average temperature. This register allows the current table index to be read by the host. The table base address must be added to LUTINDX to form a complete table index in physical memory. A valid OEM password is required for access to this register. Otherwise, reads are undefined.							

OEM Configuration 3 (OEMCFG3)							
D[7] LUTSEL read/write	D[6] TXFPOL read/write	D[5] GPOD read/write	D[4] GPOM read/write	D[3] GPOC read/write	D[2] TXFIN read/write	D[1] LOSDIS read/write	D[0] INTCAL read/write
Default Value			0000 1000 <sub>b</sub> = 08 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			19 = 13 <sub>h</sub>				
This register is non-volatile and will be maintained through power and reset cycles. A valid OEM password is required for access to this register. GPOD and GPOC are ignored when GPOM = 0. TXFPOL is ignored if TXFIN = 0.							

Bit		Function	Operation
D[7]	LUTSEL	RX power look-up table input selection bit	1 = RX power; 0 = temperature; read/write; ignored if INTCAL = 0.
D[6]	TXFPOL	TXFIN active polarity select; a fault is indicated when TXFIN = TXFPOL	0 = active-low; 1 = active-high; read/write; ignored if TXFIN = 0.
D[5]	GPOD	GPO output drive	0 = open drain; 1 = push-pull; read/write; ignored if GPOM = 0.
D[4]	GPOM	GPO/RSOUT mode select	0 = RSOUT; 1 = GPO; read/write.
D[3]	GPOC	GPO output control	0 = low; 1 = high; read/write; ignored if GPOM = 0.
D[2]	TXFIN	TXFIN mode select	0 = SHDN; 1 = TXFIN; read/write.
D[1]	LOSDIS	RXLOS comparator disable	0 = enabled; 1 = disabled; read/write.
D[0]	INTCAL	Calibration mode select	0 = external calibration; 1 = internal calibration; read/write.

BIAS DAC Setting (APCDAC) Current VBIAS Setting							
D[7] read only	D[6] read only	D[5] read only	D[4] read only	D[3] read only	D[2] read only	D[1] read only	D[0] read only
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			20 = 14 <sub>h</sub>				
This register reflects (reads back) the value set in the APC register (APCSET0, APCSET1, or APCSET2 whichever is selected). A valid OEM password is required for access to this register.							

Modulation DAC Setting (MODDAC) Current VMOD Setting							
D[7] read only	D[6] read only	D[5] read only	D[4] read only	D[3] read only	D[2] read only	D[1] read only	D[0] read only
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			21 = 15 <sub>h</sub>				
This register reflects (reads back) the value set in the MODSET register. A valid OEM password is required for access to this register.							

OEM Readback Register (OEMRD)							
D[7] reserved	D[6] reserved	D[5] reserved	D[4] INT read only	D[3] APCSAT read only	D[2] IBFLT read only	D[1] TXFLT read only	D[0] RSOUT read only
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			22 = 16 <sub>h</sub>				
This register reflects (reads back) the status of the bits corresponding to the parameters defined below. A valid OEM password is required for access to this register. Otherwise, reads are undefined and writes are ignored.							

Bit		Function	Operation
D[7:5]		Reserved	Always write as zero; reads undefined.
D[4]	INT	Mirrors state of /INT but active-high; not state of physical pin!	1 = interrupt; 0 = no interrupt.
D[3]	APCSAT	APC saturation fault comparator output state	1 = fault; 0 = normal operation.
D[2]	IBFLT	State of IBIAS over-current fault comparator output	1 = fault; 0 = normal operation; read-only.
D[1]	TXFLT	State of transmit power fault comparator output	1 = fault; 0 = normal operation; read-only.
D[0]	RSOUT	State of the rate select output pin, RSOUT	1 = high; 0 = low; Read-only.

Signal Detect Threshold (LOSFLTn)							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			23 = 17 <sub>h</sub>				
This register works in conjunction with the LOSFLT register to control the operation of the loss of signal comparator. The comparator's output, RXLOS, is asserted when the input on VRX falls below the level in LOSFLT. The output will then be de-asserted when the VRX signal rises above LOSFLTn. The input signal is subject to scaling by the RXPOT. If the LOS comparator is disabled, i.e., LOSDIS = 1, this register is ignored. A valid OEM password is required for access to this register. This register is non-volatile and will be maintained through power and reset cycles.							

RX EEPOT Tap Selection (RXPOT)							
D[7] reserved	D[6] reserved	D[5] reserved	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			24 = 18 <sub>h</sub>				
This register is non-volatile and will be maintained through power and reset cycles. A valid OEM password is required for access to these registers.							

Bit(s)	Function	Operation
D[7:5]	Reserved	Reserved. Always write as zero; reads undefined.
D[4:0]	RXPOT tap selection: 00000 = No divider action; POT disconnected 00001 = 31/32 00010 = 30/32 • • • 11110 = 2/32 11111 = 1/32	Read/write; non-volatile.

OEM Configuration 4 (OEMCFG4)							
D[7] reserved	D[6] reserved	D[5] reserved	D[4] reserved	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			25 = 19 <sub>h</sub>				
This register is non-volatile and will be maintained through power and reset cycles. A valid OEM password is required for access to these registers.							

Bit(s)	Function	Operation
D[7]	Allows Warnings to assert TXFAULT	0: Warnings do not assert TXFAULT 1: Warnings assert TXFAULT The RXPWR low warning flag does not assert TXFAULT
D[6]	Allows Alarms to assert TXFAULT	0: Alarms do not assert TXFAULT 1: Alarms assert TXFAULT The RXPWR low alarm flag does not assert TXFAULT
D[5]	Warning Latch	0: Warnings flags are latched. They are cleared by reading the register or toggling TXDISABLE. 1: Warnings flags are not latched., i.e. they are set and reset with alarm condition. The flags are also cleared by reading the register or toggling TXDISABLE.
D[4]	Alarm Latch	0: Alarms flags are latched. They are cleared by reading the register or toggling TXDISABLE. 1: Alarms flags are not latched., i.e. they are set and reset with alarm condition. The flags are also cleared by reading the register or toggling TXDISABLE.

I <sub>START</sub> [3:0]	I <sub>START</sub> current level selection: 0000 = No I <sub>START</sub> current 0001 - 1111 = 0.375mA x I <sub>START</sub> [3:0] I <sub>START</sub> is used to speed up the laser start-up after a fault occurs. The charging current of the compensation cap starts from I <sub>START</sub> instead of ramping up from 0.	Read/write; non-volatile.
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OEM Configuration 5 (OEMCFG5)							
D[7] reserved	D[6] reserved	D[5] reserved	D[4] reserved	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			26 = 1A <sub>h</sub>				
This register is non-volatile and will be maintained through power and reset cycles. A valid OEM password is required for access to these registers.							

Bit(s)	Function	Operation
D[7]	SHDN output enable / disable	0: SHDN is enabled. TXFAULT will trigger SHDN output 1: SHDN is disabled. TXFAULT has no effect on SHDN output This applies when pin 7 is set as SHDN output.
D[6]	Temperature-compensation of the temperature used to access the L.U.T.s.	0: The temperature used to index into the LUTs is not compensated (sensed temperature used) 1: The temperature used to index the LUTs is temperature-compensated (module case temperature used)
D[5]	Temperature-compensation of the temperature result in the temperature register.	0: The temperature result in the temperature register is not compensated (sensed temperature used) 1: The temperature result in the temperature register is compensated (module case temperature used)
D[4]	Polarity of TXFAULT	0: TXFAULT is active high 1: TXFAULT is active low
D[3]	SMBUS multipart support	0: Multipart mode off 1: Multipart mode on
D[2]	OEM password location	0: A6h 120-123 (78h-7Bh) 1: A6h 123-126 (7Bh-7Eh)
D[1]	SMBUS timeout enable / disable	0: SMBUS timeout enabled 1: SMBUS timeout disabled
D[0]	DACs reset	0: Clear DACs when the laser is off 1: Do not clear the DACs when laser is off

OEM Configuration 6 (OEMCFG6)							
D[7] reserved	D[6] reserved	D[5] reserved	D[4] reserved	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			27 = 1B <sub>h</sub>				
This register is non-volatile and will be maintained through power and reset cycles. A valid OEM password is required for access to these registers.							

Bit(s)	Function	Operation
D[5-7]	Reserved	
D[4]	TXDISABLE debounce enable / disable	0: TXDISABLE is not debounced 1: TXDISABLE is debounced. Glitches less than 5 ms are rejected. Set the bit to 1 if a mechanical switch is used for TXDISABLE. Set to 0 for normal operation to assure compliance to the SFP MSA.
D[3]	RXLOS Polarity	0: RXLOS low for normal operation and high with a loss of signal condition. 1: RXLOS high for normal operation (signal detected) and low with a loss of signal (no signal detected) condition.
D[2]	USRCTRL register location	0: A2 255 (FF <sub>h</sub> ) 1: A2 222 (DE <sub>h</sub> )
D[1]	Temperature resolution	0: Temperature is measured to a resolution of 1°C 1: Temperature is measured to a resolution of 0.5°C
D[0]	TXFAULT clear mode	0: TXFAULT remains set until TXDISABLE is toggled 1: TXFAULT is in continuous mode and follows the state of the faults.

Power-On Hour Meter Data (POHDATA)							
D[7] read/write	D[6] read/write	D[5] read/write	D[4] read/write	D[3] read/write	D[2] read/write	D[1] read/write	D[0] read/write
Default Value			0000 0000 <sub>b</sub> = 00 <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			32-39 = 20 <sub>h</sub> - 27 <sub>h</sub>				
These registers are used for backing up the POH result during power cycles. At power-up, the POH meter selects the larger of the two values as the initial count. Incremental results are stored in alternate register pairs. The power-on hour meter may be reset or preset by writing to these registers. These registers are non-volatile and will be maintained through power and reset cycles. A valid OEM password is required for access to these registers.							

Byte	Weight
3	POHA, high-byte
2	POHA, low-byte
1	POHB, high-byte
0	POHB, low-byte



OEM Scratchpad Registers (SCRATCHn)	
Default Value	0000 0000 <sub>b</sub> = 00 <sub>h</sub>
Serial Address	A6 <sub>h</sub>
Byte Address	135-143 (87-8F <sub>h</sub> ) 156-159 (9C-9F <sub>h</sub> ) 172-175 (AC-AF <sub>h</sub> ) 188-191 (BC-BF <sub>h</sub> ) 204-207 (CC-CF <sub>h</sub> ) 222-250 (DE-FA <sub>h</sub> )
The scratchpad registers are general-purpose non-volatile memory locations. They can be freely read from and written to any time the MIC3002 is in OEM mode.	

RX Power Look-up Table (RXLUTn)	
Default Value	0000 0000 <sub>b</sub> = 00 <sub>h</sub>
Serial Address	A6 <sub>h</sub>
Byte Address	40-71 = 28 <sub>h</sub> - 47 <sub>h</sub>
These registers are non-volatile and will be maintained through power and reset cycles. A valid OEM password is required for access to these registers.	

Bytes	Definition
RXSLP0h	RX Slope 0, High Byte.
RXSLP0l	RX Slope 0, Low Byte.
RXOFF0h	RX Offset 0, High Byte.
RXOFF0l	RX Offset 0, Low Byte.
RXSLP1h	RX Slope 1, High Byte.
RXSLP1l	RX Slope 1, Low Byte.
RXOFF1h	RX Offset 1, High Byte.
RXOFF1l	RX Offset 1, Low Byte.
•	•
•	•
•	•
RXSLP7h	RX Slope 7, High Byte.
RXSLP7l	RX Slope 7, Low Byte.
RXOFF7h	RX Offset 7, High Byte.
RXOFF7l	RX Offset 7, Low Byte.

Calibration Constants (CALn)	
Default Value	0000 0000 <sub>b</sub> = 00 <sub>h</sub>
Serial Address	A6 <sub>h</sub>
Byte Address	74 - 87 = 4A <sub>h</sub> - 57 <sub>h</sub>
These registers are non-volatile and will be maintained through power and reset cycles. A valid OEM password is required for access to these registers.	

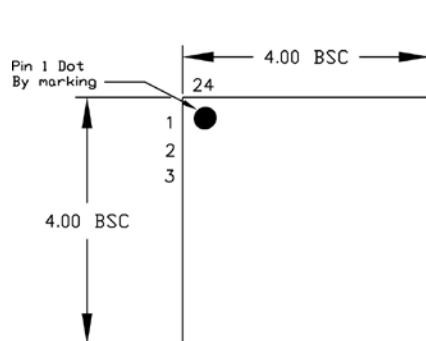
Bytes	Definition
VSLP0h	Voltage Slope, High Byte.
VSLP0l	Voltage Slope, Low Byte.
VOFFh	Voltage Offset, High Byte.
VOFF0l	Voltage Offset, Low Byte.
ISLP0h	Bias Current Slope, High Byte.
ISLP0l	Bias Current Slope, Low Byte.
IOFFh	Bias Current Offset, High Byte.
IOFF0l	Bias Current Offset, Low Byte.
TXSLPh	TX Power Slope, High Byte.
TXSLPl	TX Power Slope, Low Byte.
TXOFFh	TX Power Offset, High Byte.
TXOFFl	TX Power Offset, Low Byte.

Manufacturer ID Register (MFG_ID) Identifies Micrel as the manufacturer of the device. Always returns 2Ah							
D[7] read only	D[6] read only	D[5] read only	D[4] read only	D[3] read only	D[2] read only	D[1] read only	D[0] read only
Default Value			0010 1010 <sub>b</sub> = 2A <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			254 = FE <sub>h</sub>				
The value in this register, in combination with the DEV_ID register, serve to identify the MIC3002 and its revision number to software. This register is read-only.							

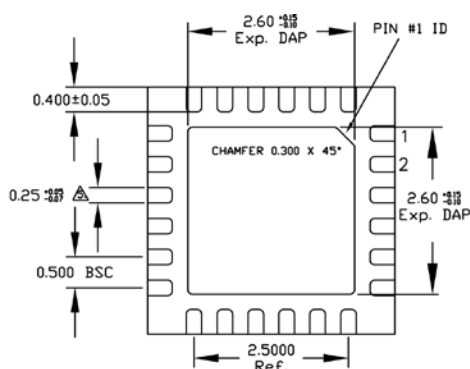
Bit(s)	Function	Operation
D[7:0]	Identifies Micrel as the manufacturer of the device. Always returns 2A <sub>h</sub> .	Read only. Always returns A <sub>h</sub>

Device ID Register (DEV_ID)							
D[7] read only	D[6] read only	D[5] read only	D[4] read only	D[3] read only	D[2] read only	D[1] read only	D[0] read only
MIC3002 DEVICE ID always reads 0 at D[5-7] and 1 at D[4]				DIE REVISION			
Default Value			0001 xxxx <sub>b</sub> = 1x <sub>h</sub>				
Serial Address			A6 <sub>h</sub>				
Byte Address			255 = FF <sub>h</sub>				
The value in this register, in combination with the MFG_ID register, serve to identify the MIC3002 and its revision number to software. This register is read-only.							

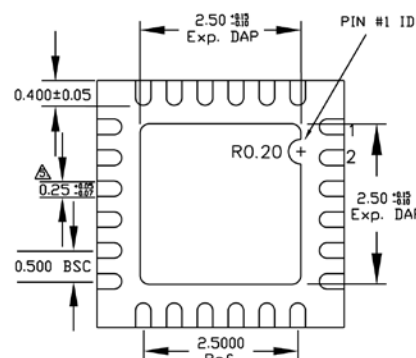
## Package Information



TOP VIEW

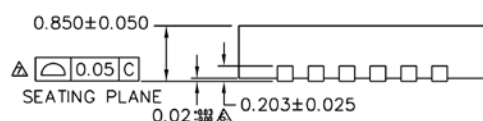


VARIATION A



VARIATION B

BOTTOM VIEW



SIDE VIEW

### NOTE:

1. ALL DIMENSIONS ARE IN MILLIMETERS.
  2. MAX. PACKAGE WARPAGE IS 0.05 mm.
  3. MAXIMUM ALLOWABLE BURRS IS 0.076 mm IN ALL DIRECTIONS.
  4. PIN #1 ID ON TOP WILL BE LASER/INK MARKED.
- △ DIMENSION APPLIES TO METALIZED TERMINAL AND IS MEASURED BETWEEN 0.20 AND 0.25 mm FROM TERMINAL TIP.
- △ APPLIED ONLY FOR TERMINALS.
- △ APPLIED FOR EXPOSED PAD AND TERMINALS.

### 24-Pin QFN

**MICREL, INC. 2180 FORTUNE DRIVE SAN JOSE, CA 95131 USA**

TEL +1 (408) 944-0800 FAX +1 (408) 474-1000 WEB <http://www.micrel.com>

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